

## Fully Integrated PMIC for Safety-Related Systems with Buck or Buck-Boost Pre-Regulator, 4× Linear Regulators, 4× Gate Drivers, and SPI

### FEATURES AND BENEFITS

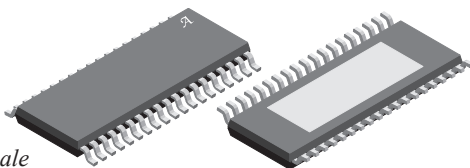
- A<sup>2</sup>-SIL™ product—device features for safety-critical systems
- Automotive AEC-Q100 qualified
- Wide input voltage range, 3.8 to 36 V<sub>IN</sub> operating range, 40 V<sub>IN</sub> maximum
- 2.2 MHz buck or buck/boost pre-regulator (VREG: 5.35 V)
- Four internal linear regulators with foldback short-circuit protection
  - VUC: selectable output (3.3 V / 5.0 V) regulator for microcontroller
  - V5C: 5 V general purpose LDO regulator
  - V5P1 and V5P2: two LDO regulators (track VUC voltage) with short-to-battery protection for remote sensors
- Q&A Watchdog and Window Watchdog timer
- Floating gate drivers with charge pump for external isolator NFET control
- Control and diagnostic reporting through a serial peripheral interface (SPI)
- Logic enable input (ENB) for microprocessor control
- Ignition enable input (ENBAT)
- Frequency dithering and controlled slew rate help reduce EMI/EMC
- Undervoltage protection for all output rails
- Thermal shutdown protection
- -40°C to 150°C junction temperature range

### APPLICATIONS

- Provides system power for (microcontroller/DSP, CAN, sensors, etc.) and high current isolation FET gate driver in automotive control modules, such as:
  - Electronic power steering (EPS)
  - Advanced braking systems (ABS)
  - Other automotive applications



### PACKAGE: 38-Pin eTSSOP (suffix LV)



Not to scale

### DESCRIPTION

The ARG82800 is a power management IC that integrates a buck or buck/boost pre-regulator, four LDOs, and four floating gate drivers. The pre-regulator uses a buck or buck/boost topology to efficiently convert automotive battery voltages into a tightly regulated intermediate voltage complete with control, diagnostics, and protections.

The output of the pre-regulator supplies a 3.3 V or 5.0 V selectable 350 mA linear regulator, a 5 V / 100 mA linear regulator, and two 120 mA protected linear regulators which track VUC output. Designed to supply power for microprocessors, sensors, and CAN transceivers, the ARG82800 is ideal for underhood applications.

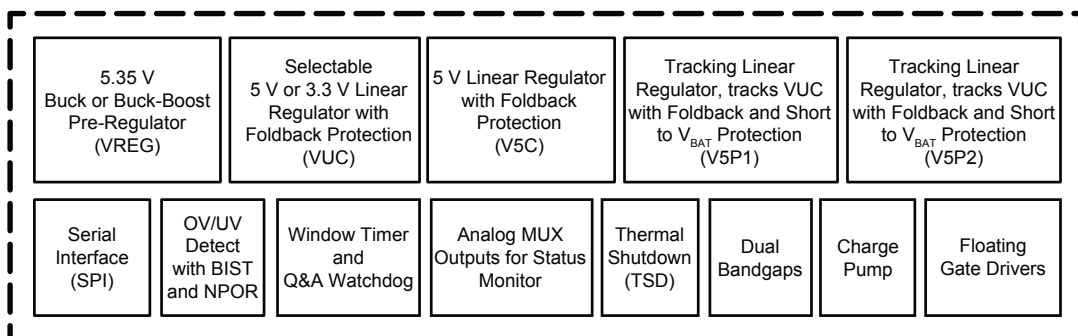
The independent floating gate drivers have the capability of controlling N-channel MOSFETs through SPI. These MOSFETs can be configured as phase or battery isolation devices in high current motor applications. An integrated charge pump allows the driver outputs to maintain the power MOSFETs in the on state over the full supply range with high phase-voltage slew rates.

Enable inputs to the ARG82800 include a logic level (ENB) and a high voltage (ENBAT). The ARG82800 also provides flexibility with disable function of the individual output rails through a serial peripheral interface (SPI).

Diagnostic outputs from the ARG82800 include a power-on-reset output (NPOR) and a fault flag output (FFn) to alert the microprocessor that a fault has occurred. The microprocessor can read fault status through SPI. Dual bandgaps, one for regulation and one for fault checking, improve safety coverage and fault detection of the ARG82800.

The ARG82800 contains two types of watchdog functions: Q&A and Window Watchdog timer. The watchdog timer is activated once it receives a valid SPI command from a processor. The watchdog can be put into flash mode or be reset via secure SPI commands.

The ARG82800 is supplied in a low-profile (1.2 mm maximum height) 38-lead eTSSOP package (suffix “LV”) with exposed power pad.



ARG82800 Simplified Block Diagram

# ARG82800

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with Buck or Buck-Boost Pre-Regulator,  
4× Linear Regulators, 4× Gate Drivers, and SPI*

## SELECTION GUIDE

Part Number	Package	Packing [1]	Lead Frame
ARG82800KLVATR	38-pin eTSSOP with thermal pad	4000 pieces per 7-inch reel	100% matte tin



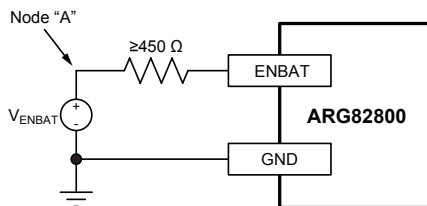
[1] Contact Allegro for additional packing options.

## ABSOLUTE MAXIMUM RATINGS [2]

Characteristic	Symbol	Notes	Rating	Unit
VIN	$V_{VIN}$		-0.3 to 40	V
ENBAT	$V_{ENBAT}$	With current limiting resistor [3]	-13 to 40	V
			-0.3 to 8	V
	$I_{ENBAT}$		±75	mA
LX	$V_{LX}$		-0.3 to $V_{VIN} + 0.3$	V
		$t < 250$ ns	-1.5	V
		$t < 50$ ns	$V_{VIN} + 3$	V
GU, GV, GW, GVBB	$V_{GU}, V_{GV}, V_{GW}, V_{GVBB}$		$V_{SX} - 0.3$ to $V_{SX} + 12$	V
SU, SV, SW, SVBB	$V_{SU}, V_{SV}, V_{SW}, V_{SVBB}$		-6 to $V_{VIN} + 5$	V
		Transient	-18 to $V_{VIN} + 5$	V
VCP1	$V_{VCP1}$		$V_{VIN} - 0.3$ to $V_{VIN} + 8$	V
VCP2	$V_{VCP2}$		$V_{VIN} - 0.3$ to $V_{VIN} + 12$	V
CP1C1	$V_{CP1C1}$	$V_{VIN} \geq 12$ V	$V_{VIN} - 12$ to $V_{VIN} + 0.3$	V
		$V_{VIN} < 12$ V	-0.3 to $V_{VIN} + 0.3$	V
CP2C1	$V_{CP2C1}$		$V_{VIN} - 0.3$ to $V_{VCP1} + 0.3$	V
CP1C2	$V_{CP1C2}$		$V_{VIN} - 0.3$ to $V_{VCP1} + 0.3$	V
CP2C2	$V_{CP2C2}$		$V_{CP1C2} - 0.3$ to $V_{VCP2} + 0.3$	V
V5P1, V5P2	$V_{V5P1}, V_{V5P2}$	Independent of $V_{VIN}$	-1.0 to 40	V
All other pins			-0.3 to 7	V
Junction Temperature	$T_J$		-40 to 150	°C
Storage Temperature Range	$T_{stg}$		-40 to 150	°C

[2] Stresses beyond those listed in this table may cause permanent damage to the device. The absolute maximum ratings are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the Electrical Characteristics table is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

[3] The higher ENBAT ratings (-13 V and 40 V) are measured at node "A" in the following circuit configuration:



## THERMAL CHARACTERISTICS: May require derating at maximum conditions; see application information

Characteristic	Symbol	Test Conditions [4]	Value	Unit
Junction to Ambient Thermal Resistance	$R_{\theta JA}$	eTSSOP-38 (LV) package	30	°C/W

[4] Additional thermal information available on the Allegro website.

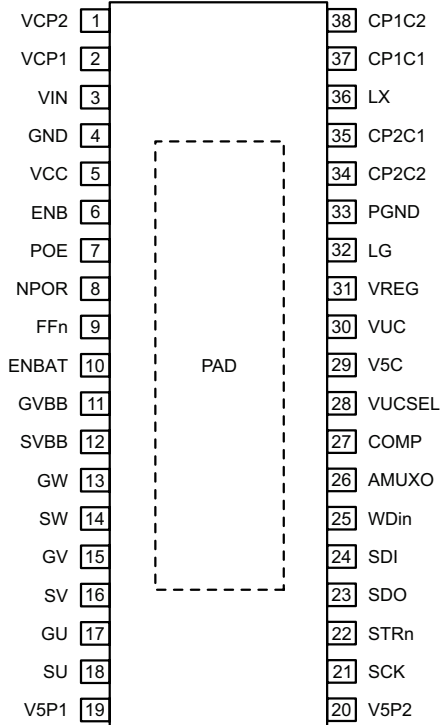


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**Package LV, 38-Pin eTSSOP  
Pinout Diagram**

**Terminal List Table**

Number	Name	Function
1	VCP2	Charge pump 2 reservoir capacitor connection
2	VCP1	Charge pump 1 reservoir capacitor connection
3	VIN	Input voltage pin
4	GND	Ground
5	VCC	Internal voltage regulator bypass capacitor pin
6	ENB	Logic enable input from a microcontroller or DSP
7	POE	Gate drive enable signal, goes low if a watchdog fault is detected
8	NPOR	Active low, open-drain regulator fault detection output
9	FFn	Fault Flag to microcontroller
10	ENBAT	Ignition enable input from the key/switch via a series resistor
11	GVBB	Battery line MOSFET gate drive
12	SVBB	Battery line MOSFET source reference
13	GW	W phase MOSFET gate drive
14	SW	W phase MOSFET source reference
15	GV	V phase MOSFET gate drive
16	SV	V phase MOSFET source reference
17	GU	U phase MOSFET gate drive
18	SU	U phase MOSFET source reference
19	V5P1	Protected regulator output (Output tracks VUC, 5 V or 3.3 V)
20	V5P2	Protected regulator output (Output tracks VUC, 5 V or 3.3 V)
21	SCK	SPI clock input from the microcontroller
22	STRn	SPI chip select input from the microcontroller
23	SDO	SPI data output to the microcontroller
24	SDI	SPI data input from the microcontroller
25	WDin	Watchdog refresh input from a microcontroller or DSP
26	AMUXO	Analog Multiplexer output
27	COMP	Error amplifier compensation network pin for the buck/boost pre-regulator
28	VUCSEL	VUC output voltage selection pin: 1 (High: should be tied to VCC), $V_{VUC} = 5\text{ V}$ 0 (Low: tied to GND), $V_{VUC} = 3.3\text{ V}$
29	V5C	5 V regulator output
30	VUC	Selectable $V_{OUT}$ (5 V or 3.3 V by VUCSEL) regulator output
31	VREG	Voltage feedback input of the pre-regulator and supply input of the linear regulators
32	LG	Boost gate drive output for the buck/boost pre-regulator
33	PGND	Power ground
34	CP2C2	Charge pump 2 capacitor connection
35	CP2C1	Charge pump 2 capacitor connection
36	LX	Switching node for the buck/boost pre-regulator
37	CP1C1	Charge pump 1 capacitor connection
38	CP1C2	Charge pump 1 capacitor connection
–	PAD	Exposed thermal pad

# ARG82800

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**ELECTRICAL CHARACTERISTICS [1]:** Valid at 3.8 V [4] ≤ V<sub>VIN</sub> ≤ 36 V, -40°C ≤ T<sub>J</sub> ≤ 150°C, V<sub>ENB</sub> = High or V<sub>ENBAT</sub> = High, unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
<b>GENERAL SPECIFICATIONS</b>						
Operating Input Voltage [2]	V <sub>VIN</sub>	After V <sub>VIN</sub> > V <sub>VIN(START)</sub> and V <sub>REG</sub> in regulating, Buck-Boost Mode	3.8	13.5	36	V
		After V <sub>VIN</sub> > V <sub>VIN(START)</sub> and V <sub>REG</sub> in regulating, Buck Mode	5.5	13.5	36	V
VIN UVLO Start Voltage	V <sub>VIN(START)</sub>	V <sub>VIN</sub> rising	4.55	4.8	5.05	V
VIN UVLO Stop Voltage	V <sub>VIN(STOP)</sub>	V <sub>VIN</sub> falling	3.25	3.5	3.75	V
VIN UVLO Hysteresis	V <sub>VIN(HYS)</sub>	V <sub>VIN(START)</sub> - V <sub>VIN(STOP)</sub>	-	1.3	-	V
VIN Supply Quiescent Current [1]	I <sub>Q</sub>	V <sub>VIN</sub> = 13.5 V, V <sub>VREG</sub> = 5.6 V (no PWM)	-	13	-	mA
	I <sub>Q(SLEEP)</sub>	V <sub>VIN</sub> = 13.5 V, V <sub>ENBAT</sub> = Low and V <sub>ENB</sub> = Low, T <sub>J</sub> = 25°C	-	-	13	μA
<b>PWM SWITCHING FREQUENCY AND DITHERING</b>						
Switching Frequency	f <sub>OSC</sub>	Dithering off	2.0	2.2	2.4	MHz
Frequency Dithering	Δf <sub>OSC</sub>	As a percent of f <sub>OSC</sub>	-	±10	-	%
VIN Dithering Start Threshold [2]	V <sub>VIN(DITHER,ON)</sub>	V <sub>VIN</sub> rising	8.5	9.0	9.5	V
		V <sub>VIN</sub> falling	-	17	-	V
VIN Dithering Stop Threshold [2]	V <sub>VIN(DITHER,OFF)</sub>	V <sub>VIN</sub> falling	7.8	8.3	8.8	V
		V <sub>VIN</sub> rising	-	18	-	V
<b>CHARGE PUMP (VCP1 AND VCP2)</b>						
VCP1 Output Voltage	V <sub>VCP1</sub>	V <sub>VCP1</sub> - V <sub>VIN</sub> , V <sub>VIN</sub> ≥ 9 V, I <sub>VCP1</sub> > -5 mA, Buck Mode	4.1	6.6	-	V
		V <sub>VCP1</sub> - V <sub>VIN</sub> , 5.5 V < V <sub>VIN</sub> ≤ 9 V, I <sub>VCP1</sub> > -5 mA, Buck Mode	3.6	4.4	-	V
		V <sub>VCP1</sub> - V <sub>VIN</sub> , 3.8 V < V <sub>VIN</sub> ≤ 5.5 V, V <sub>VREG</sub> = 5.35 V, I <sub>VCP1</sub> > -5 mA, Buck-Boost Mode	3.0	3.8	-	V
VCP2 Output Voltage	V <sub>VCP2</sub>	V <sub>VCP2</sub> - V <sub>VIN</sub> , V <sub>VIN</sub> > 9 V, I <sub>VCP2</sub> > -1 mA, Buck Mode	9	10	-	V
		V <sub>VCP2</sub> - V <sub>VIN</sub> , 5.5 V < V <sub>VIN</sub> ≤ 9 V, I <sub>VCP2</sub> > -1 mA, Buck Mode	8	10	-	V
		V <sub>VCP2</sub> - V <sub>VIN</sub> , 3.8 V < V <sub>VIN</sub> ≤ 5.5 V, V <sub>VREG</sub> = 5.35 V, I <sub>VCP2</sub> > -1 mA, Buck-Boost Mode	6.6	9.5	-	V
Switching Frequency	f <sub>SW(CP)</sub>		-	65	-	kHz
<b>VCC PIN VOLTAGE</b>						
Output Voltage	V <sub>VCC</sub>	V <sub>VREG</sub> = 5.35 V	-	4.4	-	V
<b>THERMAL PROTECTION</b>						
Thermal Shutdown Threshold [2]	T <sub>TSD</sub>	T <sub>J</sub> rising	165	-	-	°C
Thermal Shutdown Hysteresis [2]	T <sub>HYS</sub>		-	15	-	°C

[1] For input and output current specifications, negative current is defined as coming out of the node or pin (sourcing), positive current is defined as going into the node or pin (sinking).

[2] Ensured by design and characterization, not production tested.

[3] Specifications at 25°C or 85°C are guaranteed by design and characterization, not production tested.

[4] The lowest operating voltage is only valid if the conditions V<sub>VIN</sub> > V<sub>VIN(START)</sub> and V<sub>VCP</sub> - V<sub>VIN</sub> > V<sub>VCP(UV,H)</sub> and V<sub>VREG</sub> in regulating are satisfied before V<sub>VIN</sub> is reduced.

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## Fully Integrated PMIC for Safety-Related Systems with Buck or Buck-Boost Pre-Regulator, 4× Linear Regulators, 4× Gate Drivers, and SPI

**ELECTRICAL CHARACTERISTICS (continued)** [1]: Valid at  $3.8\text{ V}^{[4]} \leq V_{\text{VIN}} \leq 36\text{ V}$ ,  $-40^\circ\text{C} \leq T_J \leq 150^\circ\text{C}$ ,  $V_{\text{ENB}} = \text{High}$  or  $V_{\text{ENBAT}} = \text{High}$ , unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
<b>OUTPUT VOLTAGE SPECIFICATIONS</b>						
Pre-Regulator Output Voltage [2]	$V_{\text{VREG}}$	$V_{\text{VIN}} = 13.5\text{ V}$ , $0.1\text{ A} < I_{\text{VREG}} < 1.2\text{ A}$	5.25	5.35	5.45	V
<b>PULSE-WIDTH MODULATION (PWM)</b>						
PWM Ramp Offset	$V_{\text{PWM(OFFS)}}$	$V_{\text{COMP}}$ for 0% duty cycle	–	480	–	mV
LX Rising Slew Rate [2]	$\text{SR}_{\text{LXRISE}}$	$V_{\text{VIN}} = 13.5\text{ V}$ , 10% to 90%, $I_{\text{VREG}} = 1\text{ A}$	–	1.4	–	V/ns
LX Falling Slew Rate [2]	$\text{SR}_{\text{LXFALL}}$	$V_{\text{VIN}} = 13.5\text{ V}$ , 90% to 10%, $I_{\text{VREG}} = 1\text{ A}$	–	1.5	–	V/ns
Buck Minimum On-Time	$t_{\text{ON(BUCK,MIN)}}$		–	85	160	ns
Buck Maximum Duty Cycle	$D_{\text{BUCK(MAX)}}$	$V_{\text{VIN}} < 7.8\text{ V}$	–	–	100	%
Boost Maximum Duty Cycle	$D_{\text{BST(MAX)}}$	After $V_{\text{VIN}} > V_{\text{VIN(START)}}$ , and $V_{\text{REG}}$ in regulating, $V_{\text{VIN}} = 3.8\text{ V}$	–	65	–	%
COMP to LX Current Gain	$g_{\text{mPOWER}}$		–	4.57	–	A/V
Slope Compensation [2]	$S_{\text{E}}$		1.1	1.62	2.15	A/μs
<b>INTERNAL MOSFET</b>						
MOSFET On Resistance	$R_{\text{DS(on)}}$	$V_{\text{VIN}} = 13.5\text{ V}$ , $T_J = -40^\circ\text{C}$ [2], $I_{\text{DS}} = 0.1\text{ A}$	–	60	90	mΩ
		$V_{\text{VIN}} = 13.5\text{ V}$ , $T_J = 25^\circ\text{C}$ [3], $I_{\text{DS}} = 0.1\text{ A}$	–	95	115	mΩ
		$V_{\text{VIN}} = 13.5\text{ V}$ , $T_J = 150^\circ\text{C}$ , $I_{\text{DS}} = 0.1\text{ A}$	–	160	190	mΩ
MOSFET Leakage Current	$I_{\text{FET(LKG)}}$	$V_{\text{ENBAT}} \leq 2.2\text{ V}$ , $V_{\text{ENB}} = \text{Low}$ , $V_{\text{LX}} = 0\text{ V}$ , $V_{\text{VIN}} = 16\text{ V}$ , $-40^\circ\text{C} < T_J < 85^\circ\text{C}$ [3]	–	–	10	μA
		$V_{\text{ENBAT}} \leq 2.2\text{ V}$ , $V_{\text{ENB}} \leq \text{Low}$ , $V_{\text{LX}} = 0\text{ V}$ , $V_{\text{VIN}} = 16\text{ V}$ , $-40^\circ\text{C} < T_J < 150^\circ\text{C}$	–	50	150	μA
<b>ERROR AMPLIFIER</b>						
Open Loop Voltage Gain	$A_{\text{VOL}}$		–	60	–	dB
Transconductance	$g_{\text{mEA}}$	$V_{\text{SS}}$ (internal signal) = 750 mV	520	720	920	μA/V
		$V_{\text{SS}}$ (internal signal) = 500 mV	260	360	460	μA/V
Output Current	$I_{\text{O(EA)}}$		–	±75	–	μA
Maximum Output Voltage	$V_{\text{O(EA,MAX)}}$	$V_{\text{VIN}} < 8.5\text{ V}$	1.2	1.52	2.1	V
		$V_{\text{VIN}} > 9.5\text{ V}$	0.9	1.22	1.7	V
Minimum Output Voltage	$V_{\text{O(EA,MIN)}}$		–	–	300	mV
COMP Pull-Down Resistance	$R_{\text{COMP}}$	HICCUP = 1 or FAULT = 1 or $V_{\text{ENBAT}} = \text{Low}$ and $V_{\text{ENB}} = \text{Low}$	–	1	–	kΩ

[1] For input and output current specifications, negative current is defined as coming out of the node or pin (sourcing), positive current is defined as going into the node or pin (sinking).

[2] Ensured by design and characterization, not production tested.

[3] Specifications at  $25^\circ\text{C}$  or  $85^\circ\text{C}$  are guaranteed by design and characterization, not production tested.

[4] The lowest operating voltage is only valid if the conditions  $V_{\text{VIN}} > V_{\text{VIN(START)}}$  and  $V_{\text{VCP}} - V_{\text{VIN}} > V_{\text{VCP(UV,H)}}$  and  $V_{\text{VREG}}$  in regulating are satisfied before  $V_{\text{VIN}}$  is reduced.

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Characteristic	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
<b>BOOST MOSFET (LG) GATE DRIVER</b>						
LG High Output Voltage	$V_{LG(ON)}$	$V_{VIN} = 6\text{ V}$ , $V_{VREG} = 5.35\text{ V}$	4.6	–	5.35	V
LG Low Output Voltage	$V_{LG(OFF)}$	$V_{VIN} = 13.5\text{ V}$ , $V_{VREG} = 5.35\text{ V}$	–	0.2	0.4	V
LG Source Current <sup>[1]</sup>	$I_{LG(ON)}$	$V_{VIN} = 6\text{ V}$ , $V_{VREG} = 5.35\text{ V}$ , $V_{LG} = 1\text{ V}$	–	–300	–	mA
LG Sink Current <sup>[1]</sup>	$I_{LG(OFF)}$	$V_{VIN} = 13.5\text{ V}$ , $V_{VREG} = 5.35\text{ V}$ , $V_{LG} = 1\text{ V}$	–	150	–	mA
<b>SOFT-START</b>						
SS Ramp Time <sup>[2]</sup>	$t_{SS}$		–	900	–	$\mu\text{s}$
SS PWM Frequency Foldback	$f_{SW(SS)}$	$0\text{ V} \leq V_{VREG} < 0.67\text{ V}$ typical	–	$f_{OSC}/8$	–	–
		$0.67\text{ V} \leq V_{VREG} < 1.34\text{ V}$ typical	–	$f_{OSC}/4$	–	–
		$1.34\text{ V} \leq V_{VREG} < 2.68\text{ V}$ typical	–	$f_{OSC}/2$	–	–
		$V_{VREG} \geq 2.68\text{ V}$ typical	–	$f_{OSC}$	–	–
<b>HICCUP MODE</b>						
Hiccup Enable Delay Time <sup>[2]</sup>	$t_{HIC(EN)}$		–	230	–	$\mu\text{s}$
Hiccup Recovery Time <sup>[2]</sup>	$t_{HIC(REC)}$		–	930	–	$\mu\text{s}$
Hiccup OCP PWM Counts	$t_{HIC(OCP)}$	$V_{VREG} < 1.3\text{ V}_{TYP}$ , $V_{COMP} = V_{O(EA,MAX)}$	–	32	–	PWM cycles
		$V_{VREG} > 1.3\text{ V}_{TYP}$ , $V_{COMP} = V_{O(EA,MAX)}$	–	120	–	PWM cycles
<b>CURRENT PROTECTIONS</b>						
Pulse-by-Pulse Current Limit	$I_{LIM(ton,min)}$	$V_{VIN} < 8.5\text{ V}$	3.83	4.2	4.77	A
		$V_{VIN} > 9.5\text{ V}$	2.49	2.8	3.11	A
LX Short-Circuit Current Limit	$I_{LIM(LX)}$	Latched fault after 2 <sup>nd</sup> detection	5.3	7.1	–	A

<sup>[1]</sup> For input and output current specifications, negative current is defined as coming out of the node or pin (sourcing), positive current is defined as going into the node or pin (sinking).

<sup>[2]</sup> Ensured by design and characterization, not production tested.

<sup>[3]</sup> Specifications at 25°C or 85°C are guaranteed by design and characterization, not production tested.

<sup>[4]</sup> The lowest operating voltage is only valid if the conditions  $V_{VIN} > V_{VIN(START)}$  and  $V_{VCP} - V_{VIN} > V_{VCP(UV,H)}$  and  $V_{VREG}$  in regulating are satisfied before  $V_{VIN}$  is reduced.



# ARG82800

*Fully Integrated PMIC for Safety-Related Systems  
with Buck or Buck-Boost Pre-Regulator,  
4× Linear Regulators, 4× Gate Drivers, and SPI*

**ELECTRICAL CHARACTERISTICS (continued)** [1]: Valid at 3.8 V [4] ≤ V<sub>VIN</sub> ≤ 36 V, −40°C ≤ T<sub>J</sub> ≤ 150°C, V<sub>ENB</sub> = High or V<sub>ENBAT</sub> = High, unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
<b>MISSING ASYNCHRONOUS DIODE (D1) PROTECTION</b>						
Detection Level	V <sub>D(OPEN)</sub>		−1.9	−1.4	−1.0	V
Time Filtering [2]	t <sub>D(OPEN)</sub>		50	–	250	ns
<b>VUC, V5C, V5P1, V5P2 LINEAR REGULATORS</b>						
VUC Accuracy and Load Regulation (5 V <sub>OUT</sub> )	V <sub>VUC5</sub>	10 mA < I <sub>VUC</sub> < 350 mA, V <sub>VREG</sub> = 5.25 V, VUCSEL = 1	4.9	5.0	5.1	V
VUC Accuracy and Load Regulation (3.3 V <sub>OUT</sub> )	V <sub>VUC33</sub>	10 mA < I <sub>VUC</sub> < 350 mA, V <sub>VREG</sub> = 5.25 V, VUCSEL = 0	3.23	3.30	3.37	V
VUC Output Capacitance Range [2]	C <sub>OUT(VUC)</sub>		1.0	–	15	μF
V5C Accuracy and Load Regulation	V <sub>V5C</sub>	5 mA < I <sub>V5C</sub> < 100 mA, V <sub>VREG</sub> = 5.25 V	4.9	5.0	5.1	V
V5C Output Capacitance Range [2]	C <sub>OUT(V5C)</sub>		1.0	–	15	μF
V5P1 Accuracy and Load Regulation (5 V <sub>OUT</sub> )	V <sub>V5P1</sub>	5 mA < I <sub>V5P1</sub> < 120 mA, V <sub>VREG</sub> = 5.25 V, VUCSEL = 1	4.9	5.0	5.1	V
V5P1 Output Capacitance Range [2]	C <sub>OUT(V5P1)</sub>		1.0	–	15	μF
V5P2 Accuracy and Load Regulation (5 V <sub>OUT</sub> )	V <sub>V5P2</sub>	5 mA < I <sub>V5P2</sub> < 120 mA, V <sub>VREG</sub> = 5.25 V, VUCSEL = 1	4.9	5.0	5.1	V
V5P2 Output Capacitance Range [2]	C <sub>OUT(V5P2)</sub>		1.0	–	15	μF
V5Px Tracking Accuracy, V <sub>VUC</sub> = 3.3 V	TRACK <sub>33</sub>	I <sub>V5Px</sub> = I <sub>VUC</sub> = 60 mA, VUCSEL = 0	−0.66	–	0.66	%
V5Px Tracking Accuracy, V <sub>VUC</sub> = 5 V	V <sub>TRACK(5V)</sub>	I <sub>V5Px</sub> = I <sub>VUC</sub> = 60 mA, VUCSEL = 1	−25	–	25	mV
<b>VUC OVERCURRENT PROTECTION</b>						
VUC Current Limit [1]	I <sub>VUC(LIM)</sub>		−385	−570	−800	mA
VUC Foldback Current [1]	I <sub>VUC(FBK)</sub>	V <sub>VUC</sub> = 0 V	−60	−170	−250	mA
<b>V5C OVERCURRENT PROTECTION</b>						
V5C Current Limit [1]	I <sub>V5C(LIM)</sub>		−120	−180	−250	mA
V5C Foldback Current [1]	I <sub>V5C(FBK)</sub>	V <sub>V5C</sub> = 0 V	−15	−60	−125	mA
<b>V5P1 OVERCURRENT PROTECTION</b>						
V5P1 Current Limit [1]	I <sub>V5P1(LIM)</sub>		−135	−230	−350	mA
V5P1 Foldback Current [1]	I <sub>V5P1(FBK)</sub>	V <sub>V5P1</sub> = 0 V	−20	−60	−125	mA
<b>V5P2 OVERCURRENT PROTECTION</b>						
V5P2 Current Limit [1]	I <sub>V5P2(LIM)</sub>		−135	−230	−350	mA
V5P2 Foldback Current [1]	I <sub>V5P2(FBK)</sub>	V <sub>V5P2</sub> = 0 V	−20	−60	−125	mA

[1] For input and output current specifications, negative current is defined as coming out of the node or pin (sourcing), positive current is defined as going into the node or pin (sinking).

[2] Ensured by design and characterization, not production tested.

[3] Specifications at 25°C or 85°C are guaranteed by design and characterization, not production tested.

[4] The lowest operating voltage is only valid if the conditions V<sub>VIN</sub> > V<sub>VIN(START)</sub> and V<sub>VCP</sub> − V<sub>VIN</sub> > V<sub>VCP(UV,H)</sub> and V<sub>VREG</sub> in regulating are satisfied before V<sub>VIN</sub> is reduced.

**ELECTRICAL CHARACTERISTICS (continued) [1]: Valid at  $3.8\text{ V}^{[4]} \leq V_{\text{VIN}} \leq 36\text{ V}$ ,  $-40^{\circ}\text{C} \leq T_{\text{J}} \leq 150^{\circ}\text{C}$ ,  $V_{\text{ENB}} = \text{High}$  or  $V_{\text{ENBAT}} = \text{High}$ , unless otherwise specified**

Characteristic	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
<b>VUC, V5C, V5P1, AND V5P2 STARTUP TIMING</b>						
VUC Startup Time ( $5 V_{\text{OUT}}$ ) [2]	$t_{\text{VUC5(START)}}$	$C_{\text{VUC}} \leq 2.9\ \mu\text{F}$ , Load = $33\ \Omega \pm 5\%$ (152 mA), VUCSEL = 1	–	–	1.0	ms
VUC Startup Time ( $3.3 V_{\text{OUT}}$ ) [2]	$t_{\text{VUC33(START)}}$	$C_{\text{VUC}} \leq 2.9\ \mu\text{F}$ , Load = $33\ \Omega \pm 5\%$ (100 mA), VUCSEL = 0	–	–	1.0	ms
V5C Startup Time [2]	$t_{\text{V5C(START)}}$	$C_{\text{V5C}} \leq 2.9\ \mu\text{F}$ , Load = $100\ \Omega \pm 5\%$ (50 mA)	–	–	1.0	ms
V5P1 Startup Time [2]	$t_{\text{V5P1(START)}}$	$C_{\text{V5P1}} \leq 2.9\ \mu\text{F}$ , Load = $100\ \Omega \pm 5\%$	–	–	1.0	ms
V5P2 Startup Time [2]	$t_{\text{V5P2(START)}}$	$C_{\text{V5P2}} \leq 2.9\ \mu\text{F}$ , Load = $100\ \Omega \pm 5\%$	–	–	1.0	ms
<b>IGNITION ENABLE (ENBAT) INPUT</b>						
ENBAT Thresholds	$V_{\text{ENBAT(H)}}$	$V_{\text{ENBAT}}$ rising	2.9	3.1	3.5	V
	$V_{\text{ENBAT(L)}}$	$V_{\text{ENBAT}}$ falling	2.2	2.6	2.9	V
ENBAT Hysteresis	$V_{\text{ENBAT(HYS)}}$	$V_{\text{ENBAT(H)}} - V_{\text{ENBAT(L)}}$	–	500	–	mV
ENBAT Bias Current [1]	$I_{\text{ENBAT(BIAS)}}$	$V_{\text{ENBAT}} = 0.8\text{ V}$ via a $1\text{ k}\Omega$ series resistor	–	–	5	$\mu\text{A}$
		$V_{\text{ENBAT}} = 5.5\text{ V}$ via a $1\text{ k}\Omega$ series resistor	–	50	100	$\mu\text{A}$
		$V_{\text{ENBAT}} = 20\text{ V}$ via a $1\text{ k}\Omega$ series resistor	–	–	2	mA
ENBAT Pulldown Resistance	$R_{\text{ENBAT}}$	$V_{\text{ENBAT}} < 1.2\text{ V}$	–	600	–	k $\Omega$
<b>LOGIC ENABLE (ENB) INPUT</b>						
ENB Thresholds	$V_{\text{ENB(H)}}$	$V_{\text{ENB}}$ rising	–	–	2.0	V
	$V_{\text{ENB(L)}}$	$V_{\text{ENB}}$ falling	0.8	–	–	V
ENB Bias Current [1]	$I_{\text{ENB(IN)}}$	$V_{\text{ENB}} = 3.3\text{ V}$	–	–	175	$\mu\text{A}$
ENB Resistance	$R_{\text{ENB}}$		–	60	–	k $\Omega$
<b>ENB/ENBAT FILTER/DEGLITCH</b>						
Enable Filter/Deglitch Time	$t_{\text{d(EN)}}$		10	15	20	$\mu\text{s}$
<b>VUC, V5C, V5P1, AND V5P2 UNDERVOLTAGE PROTECTION THRESHOLDS</b>						
VUC ( $5 V_{\text{OUT}}$ ), V5C, V5P1, and V5P2 Undervoltage Thresholds	$V_{\text{V5(UV,H)}}$	$V_{\text{V5}}$ rising, VUCSEL = 1	–	4.68	–	V
	$V_{\text{V5(UV,L)}}$	$V_{\text{V5}}$ falling, VUCSEL = 1	4.50	4.65	4.80	V
VUC ( $3.3 V_{\text{OUT}}$ ) Undervoltage Thresholds	$V_{\text{V33(UV,H)}}$	$V_{\text{V33}}$ rising, VUCSEL = 0	–	3.12	–	V
	$V_{\text{V33(UV,L)}}$	$V_{\text{V33}}$ falling, VUCSEL = 0	2.8	3.1	3.19	V
VUC ( $5 V_{\text{OUT}}$ ), V5C, V5P1, and V5P2 Undervoltage Hysteresis	$V_{\text{V5(UV,HYS)}}$	$V_{\text{V5(UV,H)}} - V_{\text{V5(UV,L)}}$	–	30	–	mV
VUC ( $3.3 V_{\text{OUT}}$ ) Undervoltage Hysteresis	$V_{\text{V33(UV,HYS)}}$	$V_{\text{V33(UV,H)}} - V_{\text{V33(UV,L)}}$	–	20	–	mV

[1] For input and output current specifications, negative current is defined as coming out of the node or pin (sourcing), positive current is defined as going into the node or pin (sinking).

[2] Ensured by design and characterization, not production tested.

[3] Specifications at  $25^{\circ}\text{C}$  or  $85^{\circ}\text{C}$  are guaranteed by design and characterization, not production tested.

[4] The lowest operating voltage is only valid if the conditions  $V_{\text{VIN}} > V_{\text{VIN(START)}}$  and  $V_{\text{VCP}} - V_{\text{VIN}} > V_{\text{VCP(UV,H)}}$  and  $V_{\text{VREG}}$  in regulating are satisfied before  $V_{\text{VIN}}$  is reduced.

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## Fully Integrated PMIC for Safety-Related Systems with Buck or Buck-Boost Pre-Regulator, 4× Linear Regulators, 4× Gate Drivers, and SPI

**ELECTRICAL CHARACTERISTICS (continued) [1]:** Valid at  $3.8\text{ V}^{[4]} \leq V_{\text{VIN}} \leq 36\text{ V}$ ,  $-40^\circ\text{C} \leq T_{\text{J}} \leq 150^\circ\text{C}$ ,  $V_{\text{ENB}} = \text{High}$  or  $V_{\text{ENBAT}} = \text{High}$ , unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
<b>VUC, V5C, V5P1, AND V5P2 OVERVOLTAGE PROTECTION THRESHOLDS</b>						
VUC (5 $V_{\text{OUT}}$ ), V5C, V5P1, and V5P2 Overvoltage Thresholds	$V_{\text{V5(OV,H)}}$	$V_{\text{V5}}$ rising, VUCSEL = 1	5.15	5.33	5.5	V
	$V_{\text{V5(OV,L)}}$	$V_{\text{V5}}$ falling, VUCSEL = 1	–	5.30	–	V
VUC, V5P1, and V5P2 (3.3 $V_{\text{OUT}}$ ) Overvoltage Thresholds	$V_{\text{V33(OV,H)}}$	$V_{\text{V33}}$ rising, VUCSEL = 0	3.41	3.51	3.62	V
	$V_{\text{V33(OV,L)}}$	$V_{\text{V33}}$ falling, VUCSEL = 0	–	3.49	–	V
VUC (5 $V_{\text{OUT}}$ ), V5C, V5P1, and V5P2 Overvoltage Hysteresis	$V_{\text{V5(OV,HYS)}}$	$V_{\text{V5(OV,H)}} - V_{\text{V5(OV,L)}}$	–	30	–	mV
VUC, V5P1, and V5P2 (3.3 $V_{\text{OUT}}$ ) Overvoltage Hysteresis	$V_{\text{V33(OV,HYS)}}$	$V_{\text{V33(OV,H)}} - V_{\text{V33(OV,L)}}$	–	20	–	mV
V5Px Output Disconnect Threshold	$V_{\text{V5PX(DISC)}}$	$V_{\text{V5PX}}$ rising	–	7.2	–	V
<b>VREG, VCPX, AND BG THRESHOLDS</b>						
VREG Non-Latching Overvoltage Threshold	$V_{\text{VREG(OV,H)}}$	$V_{\text{VREG}}$ rising, LX PWM disabled	5.70	5.95	6.20	V
	$V_{\text{VREG(OV,L)}}$	$V_{\text{VREG}}$ falling, LX PWM enabled	–	5.85	–	V
VREG Non-Latching Overvoltage Hysteresis	$V_{\text{VREG(OV,HYS)}}$	$V_{\text{VREG(OV,H)}} - V_{\text{VREG(OV,L)}}$	–	100	–	mV
VREG Undervoltage Thresholds	$V_{\text{VREG(UV,H)}}$	$V_{\text{VREG}}$ rising, triggers rise of VUC linear regulator	4.14	4.38	4.62	V
	$V_{\text{VREG(UV,L)}}$	$V_{\text{VREG}}$ falling	–	4.28	–	V
VREG Undervoltage Hysteresis	$V_{\text{VREG(UV,HYS)}}$	$V_{\text{VREG(UV,H)}} - V_{\text{VREG(UV,L)}}$	–	100	–	mV
VCP1 Overvoltage Thresholds [2]	$V_{\text{VCP1(OV,H)}}$	$V_{\text{VCP1}}$ rising (w.r.t. $V_{\text{VIN}}$ )	11.0	12.5	14.0	V
VCP1 Undervoltage Thresholds	$V_{\text{VCP1(UV,H)}}$	$V_{\text{VCP1}}$ rising, PWM enabled (w.r.t. $V_{\text{VIN}}$ )	2.9	3.1	3.35	V
	$V_{\text{VCP1(UV,L)}}$	$V_{\text{VCP1}}$ falling, PWM disabled (w.r.t. $V_{\text{VIN}}$ )	–	2.8	–	V
VCP1 Undervoltage Hysteresis	$V_{\text{VCP1(UV,HYS)}}$	$V_{\text{VCP1(UV,H)}} - V_{\text{VCP1(UV,L)}}$	–	400	–	mV
VCP2 Undervoltage Thresholds	$V_{\text{VCP2(UV,H)}}$	$V_{\text{VCP2}}$ rising, PWM enabled (w.r.t. $V_{\text{VIN}}$ )	5.95	6.3	6.65	V
	$V_{\text{VCP2(UV,L)}}$	$V_{\text{VCP2}}$ falling, PWM disabled (w.r.t. $V_{\text{VIN}}$ )	–	5.1	–	V
VCP2 Undervoltage Hysteresis	$V_{\text{VCP2(UV,HYS)}}$	$V_{\text{VCP2(UV,H)}} - V_{\text{VCP2(UV,L)}}$	–	1.2	–	V
BG1 and BG2 Undervoltage Thresholds [2]	$V_{\text{BGx(UV)}}$	$V_{\text{BG1}}$ or $V_{\text{BG2}}$ falling	1.00	1.05	1.10	V
<b>OVERVOLTAGE FILTERING/DEGLITCH TIME</b>						
Overvoltage Detection Delay [2]	$t_{\text{d(OV)}}$	Overvoltage detection delay time	5	–	25	$\mu\text{s}$
<b>UNDERVOLTAGE FILTERING/DEGLITCH TIME</b>						
Undervoltage Filter/Deglitch Times [2]	$t_{\text{d(UV)}}$	Undervoltage detection delay time	5	–	25	$\mu\text{s}$

[1] For input and output current specifications, negative current is defined as coming out of the node or pin (sourcing), positive current is defined as going into the node or pin (sinking).

[2] Ensured by design and characterization, not production tested.

[3] Specifications at  $25^\circ\text{C}$  or  $85^\circ\text{C}$  are guaranteed by design and characterization, not production tested.

[4] The lowest operating voltage is only valid if the conditions  $V_{\text{VIN}} > V_{\text{VIN(START)}}$  and  $V_{\text{VCP}} - V_{\text{VIN}} > V_{\text{VCP(UV,H)}}$  and  $V_{\text{VREG}}$  in regulating are satisfied before  $V_{\text{VIN}}$  is reduced.

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*Fully Integrated PMIC for Safety-Related Systems  
with Buck or Buck-Boost Pre-Regulator,  
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**ELECTRICAL CHARACTERISTICS (continued)** [1]: Valid at  $3.8\text{ V} \leq V_{\text{VIN}} \leq 36\text{ V}$ ,  $-40^\circ\text{C} \leq T_J \leq 150^\circ\text{C}$ ,  $V_{\text{ENB}} = \text{High}$  or  $V_{\text{ENBAT}} = \text{High}$ , unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
<b>NPOR TURN-ON AND TURN-OFF DELAYS</b>						
NPOR Turn-on Delay	$t_{\text{d(NPOR,ON)}}$	Time from when VUC and V5C are all in regulation to NPOR being asserted high	15	20	25	ms
<b>NPOR OUTPUT VOLTAGES</b>						
NPOR Output Low Voltage	$V_{\text{NPOR(L)}}$	$V_{\text{VIN}} \geq 2.5\text{ V}$ , $I_{\text{NPOR}} = 2\text{ mA}$	–	150	400	mV
NPOR Leakage Current [1]	$I_{\text{NPOR(LKG)}}$	$V_{\text{NPOR}} = 3.3\text{ V}$	–	–	2	$\mu\text{A}$
<b>NPOR ONE-SHOT TIME</b>						
NPOR One-Shot “Low” Time After Watchdog Fault	$t_{\text{WD(FAULT)}}$		1.6	2	2.4	ms
<b>FAULT FLAG OUTPUT VOLTAGES (FFn)</b>						
FFn Output Voltage	$V_{\text{FF(L)}}$	FFn is tripped, $V_{\text{VIN}} \geq 2.5\text{ V}$ , $I_{\text{FF}} = 2\text{ mA}$	–	150	400	mV
FFn Leakage Current	$I_{\text{FF(LKG)}}$	$V_{\text{FF}} = 3.3\text{ V}$	–	–	2	$\mu\text{A}$
<b>WD<sub>IN</sub> VOLTAGE THRESHOLDS AND CURRENT</b>						
WD <sub>IN</sub> Input Voltage Thresholds	$V_{\text{WDIN(LO)}}$	$V_{\text{WDIN}}$ falling	0.8	–	–	V
	$V_{\text{WDIN(HI)}}$	$V_{\text{WDIN}}$ rising	–	–	2.0	V
WD <sub>IN</sub> Pull-Down Resistance [2]	$R_{\text{WDIN}}$		–	50	–	k $\Omega$
<b>WD<sub>IN</sub> TIMING SPECIFICATIONS</b>						
WD <sub>IN</sub> Duty Cycle [2]	$D_{\text{WDIN}}$		–	50	–	%
Watchdog Activation Delay	$t_{\text{d(WD)}}$		–	30	–	ms
<b>GATE DRIVE ENABLE (POE)</b>						
POE Output Voltage	$V_{\text{POE(L)}}$	$I_{\text{POE}} = 4\text{ mA}$	–	150	400	mV
	$V_{\text{POE(H)}}$	$I_{\text{POE}} = -1.5\text{ mA}$	$0.8 \times V_{\text{VUC}}$	–	–	V
<b>VUCSEL LOGIC INPUT</b>						
VUCSEL Thresholds	$V_{\text{VUCSEL(H)}}$	$V_{\text{VUCSEL}}$ rising	–	–	2.0	V
	$V_{\text{VUCSEL(L)}}$	$V_{\text{VUCSEL}}$ falling	0.8	–	–	V

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[2] Ensured by design and characterization, not production tested.

[3] Specifications at 25°C or 85°C are guaranteed by design and characterization, not production tested.

[4] The lowest operating voltage is only valid if the conditions  $V_{\text{VIN}} > V_{\text{VIN(START)}}$  and  $V_{\text{VCP}} - V_{\text{VIN}} > V_{\text{VCP(UV,H)}}$  and  $V_{\text{VREG}}$  in regulating are satisfied before  $V_{\text{VIN}}$  is reduced.

**ELECTRICAL CHARACTERISTICS (continued)** [1]: Valid at  $3.8\text{ V}^{[4]} \leq V_{VIN} \leq 36\text{ V}$ ,  $-40^\circ\text{C} \leq T_J \leq 150^\circ\text{C}$ ,  $V_{ENB} = \text{High}$  or  $V_{ENBAT} = \text{High}$ , unless otherwise specified

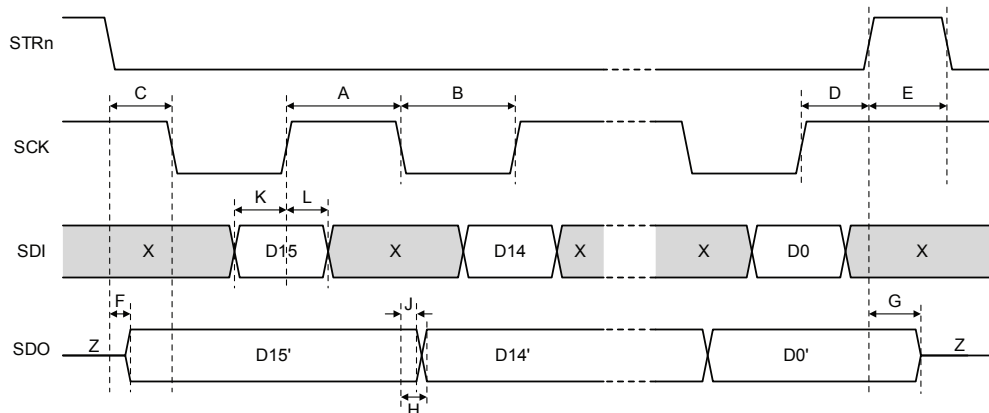
Characteristic	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
<b>SERIAL INTERFACE (STRn, SDI, SDO, SCK)</b>						
Input Low Voltage	$V_{IL}$		–	–	0.8	V
Input High Voltage	$V_{IH}$	All logic inputs	2.0	–	–	V
Input Hysteresis	$V_{Ihys}$	All logic inputs	250	550	–	mV
Input Pull-Down SDI, SCK	$R_{PDS}$	$0\text{ V} < V_{VIN} < 5\text{ V}$	–	50	–	$k\Omega$
Input Pull-Up To VCC	$I_{PU}$	STRn	–	50	–	$k\Omega$
Output Low Voltage	$V_{OL}$	$I_{OL} = 1\text{ mA}^{[1]}$	–	–	0.4	V
Output High Voltage	$V_{OH}$	$I_{OL} = -1\text{ mA}^{[1]}$	$0.8 \times V_{VUC}$	–	–	V
Clock High Time	$t_{SCKH}$	A in Figure 1	50	–	–	ns
Clock Low Time	$t_{SCKL}$	B in Figure 1	50	–	–	ns
Strobe Lead Time	$t_{STLD}$	C in Figure 1	30	–	–	ns
Strobe Lag Time	$t_{STLG}$	D in Figure 1	30	–	–	ns
Strobe High Time	$t_{STRH}$	E in Figure 1	300	–	–	ns
Data Out Enable Time	$t_{SDOE}$	F in Figure 1	–	–	40	ns
Data Out Disable Time	$t_{SDOD}$	G in Figure 1	–	–	30	ns
Data Out Valid Time From Clock Falling	$t_{SDOV}$	H in Figure 1	–	–	40	ns
Data Out Hold Time From Clock Falling	$t_{SDOH}$	J in Figure 1	5	–	–	ns
Data In Setup Time To Clock Rising	$t_{SDIS}$	K in Figure 1	15	–	–	ns
Data In Hold Time From Clock Rising	$t_{SDIH}$	L in Figure 1	10	–	–	ns
Wake Up From Sleep	$t_{EN}$		–	–	2	ms

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[3] Specifications at 25°C or 85°C are guaranteed by design and characterization, not production tested.

[4] The lowest operating voltage is only valid if the conditions  $V_{VIN} > V_{VIN(START)}$  and  $V_{VCP} - V_{VIN} > V_{VCP(UV,H)}$  and  $V_{VREG}$  in regulating are satisfied before  $V_{VIN}$  is reduced.



**Figure 1: Serial Interface Timing**  
X = do not exceed Watchdog Config timeout; Z = high-impedance (tri-state)

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## Fully Integrated PMIC for Safety-Related Systems with Buck or Buck-Boost Pre-Regulator, 4× Linear Regulators, 4× Gate Drivers, and SPI

**ELECTRICAL CHARACTERISTICS (continued)** [1]: Valid at  $3.8\text{ V}^{[4]} \leq V_{\text{VIN}} \leq 36\text{ V}$ ,  $-40^\circ\text{C} \leq T_J \leq 150^\circ\text{C}$ ,  $V_{\text{ENB}} = \text{High}$  or  $V_{\text{ENBAT}} = \text{High}$ , unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
<b>Gate Output Drive</b>						
Turn-On Time	$t_r$	$C_{\text{LOAD}} = 10\text{ nF}$ , 20% to 80%	–	5	–	$\mu\text{s}$
Turn-Off Time	$t_f$	$C_{\text{LOAD}} = 10\text{ nF}$ , 80% to 20%	–	0.5	–	$\mu\text{s}$
Turn-On Pulse Current	$I_{\text{GXP}}$		8.5	10	12	mA
Turn-On Pulse Time	$t_{\text{GXP}}$		22	–	42	$\mu\text{s}$
On Hold Current	$I_{\text{GXH}}$		–	400	–	$\mu\text{A}$
Pull-Down On Resistance	$R_{\text{DS(on)DN}}$	$T_J = 25^\circ\text{C}$ , $I_{\text{Gx}} = 10\text{ mA}$	–	5	–	$\Omega$
		$T_J = 150^\circ\text{C}$ , $I_{\text{Gx}} = 10\text{ mA}$	–	10	–	$\Omega$
Gx Output High Voltage	$V_{\text{GH}}$	$V_{\text{VIN}} > 5.5\text{ V}$ (w.r.t. Sx, or VIN if $V_{\text{Sx}} > V_{\text{VIN}}$ )	8	9	12	V
		$5.0\text{ V} < V_{\text{VIN}} \leq 5.5\text{ V}$ (w.r.t. Sx, or VIN if $V_{\text{Sx}} > V_{\text{VIN}}$ ), Buck-boost mode	7.2	9	–	V
		$V_{\text{VIN}} = 4.5\text{ V}$ , $V_{\text{Sx}} = 5.5\text{ V}$ (w.r.t. Sx), Buck-boost mode	6.2	6.9	–	V
Gate Drive Static Load Resistance [2]	$R_{\text{GS}}$	Between Gx and Sx (using $\pm 1\%$ tolerance resistor)	100	–	–	k $\Omega$
Gx Output Voltage Low	$V_{\text{GL}}$	$-10\text{ }\mu\text{A} < I_{\text{Gx}} < 10\text{ }\mu\text{A}$	–	–	$V_{\text{Sx}} + 0.3$	V
Gx Passive Pull-Down	$R_{\text{GPD}}$	$V_{\text{Gx}} - V_{\text{Sx}} < 0.3\text{ V}$	–	950	–	k $\Omega$
SVBB Undervoltage Threshold Falling	$V_{\text{SVBB(UV,L)}}$	$V_{\text{SVBB}}$ falling (w.r.t. GND)	–	–	3	V
SVBB Undervoltage Filter/Deglitch Times	$t_{\text{d(UV,FILT,BB)}}$	Undervoltage detection delay time	–	0.8	1.0	ms
SU Undervoltage Threshold Falling	$V_{\text{SUUV(L)}}$	$V_{\text{SU}}$ falling (w.r.t. GND); see 0x09 [D7]	–	–	3	V
SU Undervoltage Filter/Deglitch Times	$t_{\text{d(UV,FILT,SW)}}$	Undervoltage detection delay time; see 0x09 [D7]	–	0.8	1.0	ms
GSx Undervoltage Threshold Rising [2]	$V_{\text{GSx(UV,H)}}$	$V_{\text{Gx}}$ rising (w.r.t. Sx, x = VBB, U, V, W)	6.0	–	7.0	V
GSx Undervoltage Threshold Hysteresis [2]	$V_{\text{GSx(UV,HYS)}}$	x = VBB, U, V, W	–	250	–	mV
GSx Undervoltage Filter/Deglitch Time	$t_{\text{d(UV,FILT,GSx)}}$	Undervoltage detection delay time, x = VBB, U, V, W	–	1.4	–	ms
<b>GATE OUTPUT DRIVE</b>						
ENVBB Enable/Disable Delay Time	$t_{\text{d(EN,BB)}}$	From “SPI command is written” to GVBB 20% (enable), to GVBB 80% (disable)	–	1.5	–	ms
ENU, V, and W Enable/Disable Delay Time	$t_{\text{d(EN,X)}}$	From “SPI command is written” to Gx 20% (enable), to Gx 80% (disable); see 0x09 [D7]	–	10	–	ms
ENU Enable/Disable Delay Time	$t_{\text{d(EN,U)}}$	From “SPI command is written” to GU 20% (enable), to GU 80% (disable); see 0x09 [D7]	–	1.5	–	ms

[1] For input and output current specifications, negative current is defined as coming out of the node or pin (sourcing), positive current is defined as going into the node or pin (sinking).

[2] Ensured by design and characterization, not production tested.

[3] Specifications at  $25^\circ\text{C}$  or  $85^\circ\text{C}$  are guaranteed by design and characterization, not production tested.

[4] The lowest operating voltage is only valid if the conditions  $V_{\text{VIN}} > V_{\text{VIN(START)}}$  and  $V_{\text{VCP}} - V_{\text{VIN}} > V_{\text{VCP(UV,H)}}$  and  $V_{\text{VREG}}$  in regulating are satisfied before  $V_{\text{VIN}}$  is reduced.

# ARG82800

*Fully Integrated PMIC for Safety-Related Systems  
with Buck or Buck-Boost Pre-Regulator,  
4× Linear Regulators, 4× Gate Drivers, and SPI*

**Table 1: Startup and Shutdown Logic (signal names consistent with Block Diagram)**

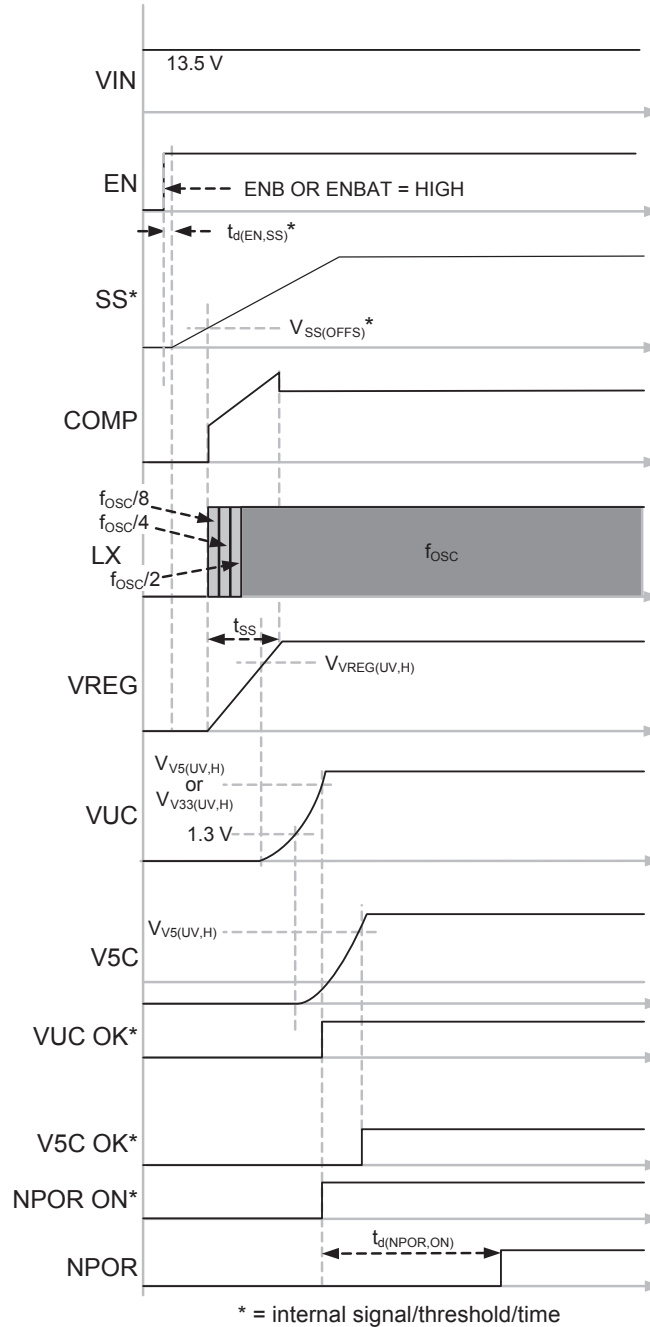
ARG82800 MODE	Regulator/Isolator Control Bits (0 = OFF, 1 = ON, R = Ready)					ARG82800 Status Signals						
	VREG ON	VUC ON	V5C ON	V5P1 and V5P2 ON	Isolator Drivers	EN	MPOR	VREG UV	VUC UV	V5C UV	V5P1 and V5P2 UV	NPOR
RESET	0	0	0	0	0	0	1	0	0	0	0	0
OFF	0	0	0	0	0	0	0	1	1	1	1	0
STARTUP	1	0	0	0	0	1	0	1	1	1	1	0
↓	1	1	0	0	R	1	0	0	1	1	1	0
↓	1	1	1	0	R	1	0	0	0	1	1	1
↓	1	1	1	R	R	1	0	0	0	0	1	1
RUN	1	1	1	R	R	1	0	0	0	0	0	1
15 μs DEGLITCH	1	1	1	R	R	0	0	0	0	0	0	0
SHUTTING DOWN	1	1	0	0	R	0	0	0	0	0	0	0
↓	1	0	0	0	0	0	0	0	0	1	1	0
↓	0	0	0	0	0	0	0	0	1	1	1	0
OFF	0	0	0	0	0	0	0	1	1	1	1	0

TIME

X = DON'T CARE

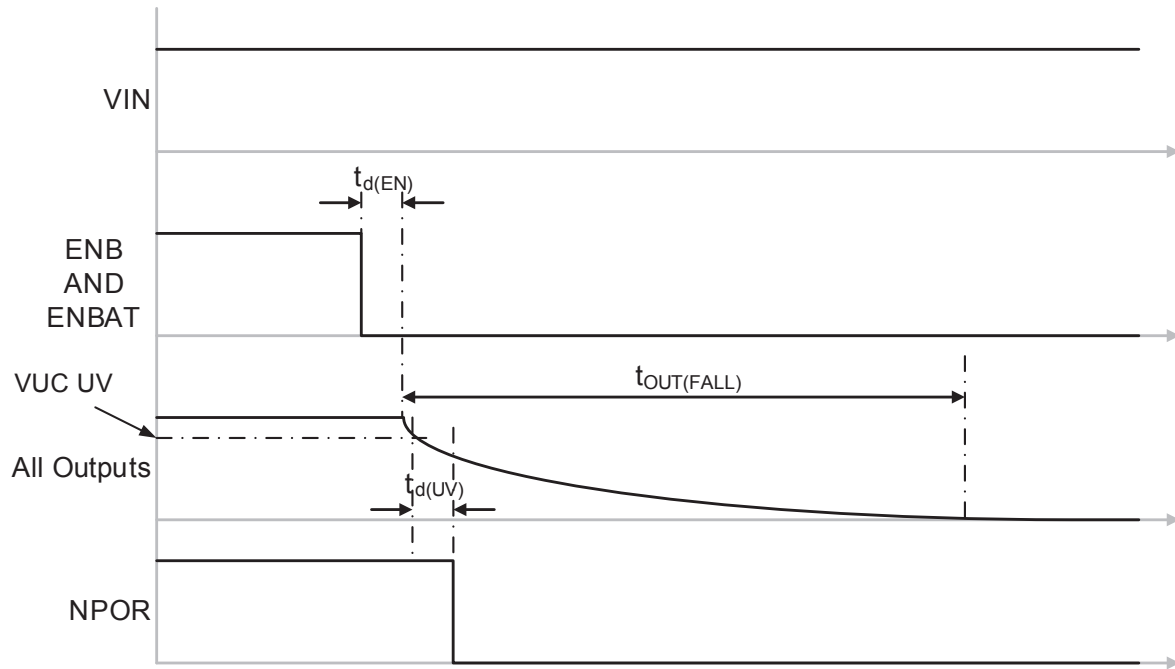
EN = ENBAT + ENB

MPOR = VCC\_UV + VCPx\_UV + BG1\_UV + BG2\_UV + TSD + D1<sub>MISSING</sub> (latched) + I<sub>LIM(LX)</sub> (latched)



**Figure 2: Startup Timing Diagram**





All outputs start to decay  $t_{d(EN)}$  seconds after ENB and ENBAT are low.  
Time for outputs to drop to zero,  $t_{OUT(FALL)}$ , varies for each output and depends on load current and capacitance.  
NPOR falls when VUC reaches its UV point.

**Figure 3: Shutdown Timing Diagram**

### TIMING DIAGRAMS (not to scale)

\* = internal signal/threshold, + is for “or”

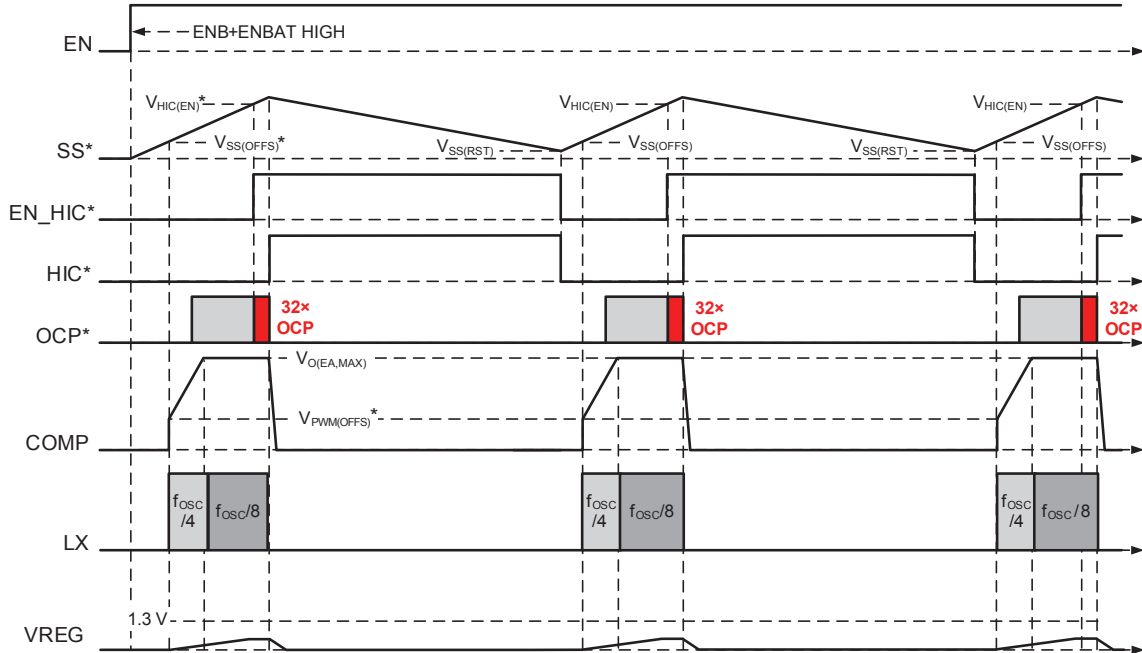


Figure 4: Hiccup Mode Operation with VREG Shorted to GND ( $R_{LOAD} < 50 \text{ m}\Omega$ )

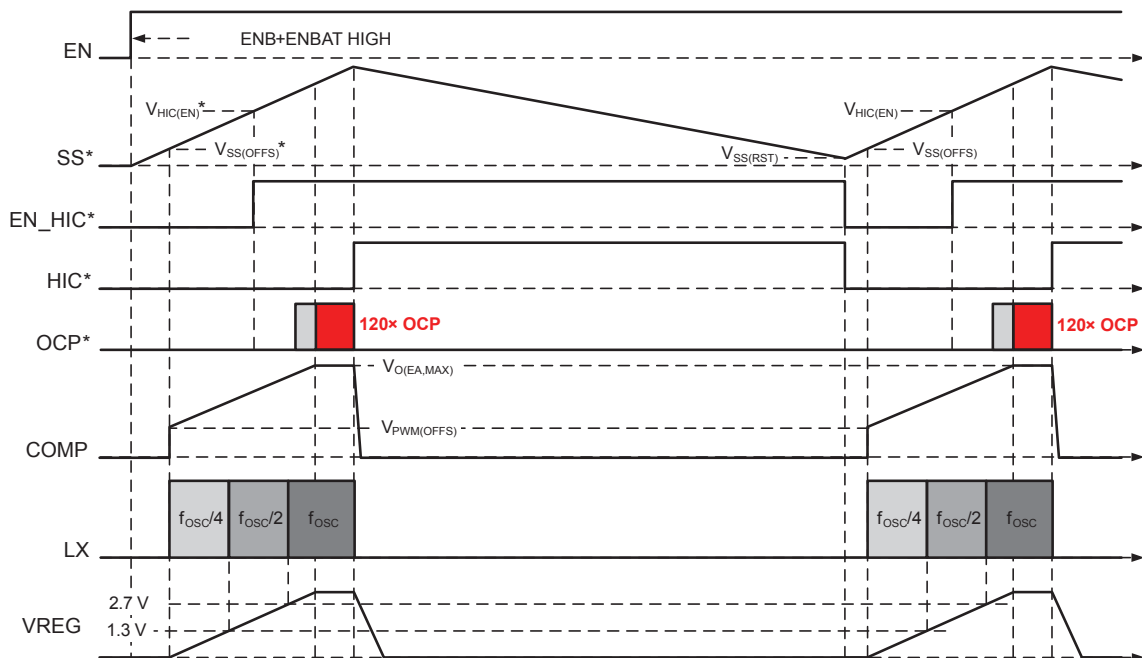


Figure 5: Hiccup Mode Operation with VREG Overloaded ( $R_{LOAD} \approx 0.5 \Omega$ )

**Table 2: Summary of Fault Mode Operation**

FAULT TYPE and CONDITION	ARG82800 RESPONSE TO FAULT	LATCHED FAULT?	VCC	VCP1	VCP2	VREG	VUC	V5C	V5P1	V5P2	Isolator Drivers	NPOR	FFn	POE	SPI	WD	RESET METHOD
VREG asynchronous diode (D1) missing	Results in an MPOR after 1 detection, so all regulators are shut off	Yes	No effect	No effect	No effect	Off	Off	Off	Off	Off	Off	Low	Low	Low	Off	Off	Place D1 then cycle EN or VIN
Asynchronous diode (D1) short-circuited or LX shorted to ground	Results in an MPOR after the high-side MOSFET current exceeds $I_{LIM(LX)}$ so all regulators are shut off	Yes	No effect	No effect	No effect	Off	Off	Off	Off	Off	Off	Low	Low	Low	Off	Off	Remove the short then cycle EN or VIN
VCP1 OV	If OV condition persists for more than $t_{OV}$ , then set FFn Low	No	No effect	$> V_{VCP1(OV,H)}$	No effect	No effect	No effect	No effect	No effect	No effect	No effect	No effect	Low	No effect	On	On	Check for short circuits on VCP1
VIN UVLO	ARG82800 is in reset state	No	Ramping	VIN	VIN	Off	Off	Off	Off	Off	Off	Low	Low	Low	Off	Off	Increase VIN
BG1 UVLO	ARG82800 is in reset state	No	Ramping	VIN	VIN	Off	Off	Off	Off	Off	Off	Low	Low	Low	Off	Off	Replace ARG82800
BG2 UVLO	ARG82800 is in reset state	No	Ramping	VIN	VIN	Off	Off	Off	Off	Off	Off	Low	Low	Low	Off	Off	Replace ARG82800
VCC UVLO	ARG82800 is in reset state	No	UVLO	VIN	VIN	Off	Off	Off	Off	Off	Off	Low	Low	Low	Off	Off	Remove the short circuit
VCC short limit	ARG82800 is in reset state	No	UVLO	VIN	VIN	Off	Off	Off	Off	Off	Off	Low	Low	Low	Off	Off	Remove the short circuit
VCP1 UVLO	ARG82800 is in reset state	No	ON	UVLO	No effect	Off	Off	Off	Off	Off	Off	Low	Low	Low	Off	Off	Remove the short circuit
VCP2 UVLO	Terminate isolator portion	No	ON	No effect	UVLO	No effect	No effect	No effect	No effect	No effect	Off	No effect	Low	Low	No effect	No effect	Remove the short circuit
VREG overvoltage $V_{VREG(OV,H)} < V_{VREG}$	Stop PWM switching of LX	No	No effect	No effect	No effect	$> V_{VREG(OV,H)}$	No effect	No effect	No effect	No effect	No effect	No effect	Low	No effect	No effect	No effect	Check for short circuits on VREG
VREG pin open circuit	VREG will decay to 0 V, LX will switch at maximum duty cycle so the voltage on the output capacitors will be very close to VBAT	No	No effect	No effect	No effect	Decay to 0 V	Off if $V_{VREG} < UVLO$	Off if $V_{VREG} < UVLO$	Off if $V_{VREG} < UVLO$	Off if $V_{VREG} < UVLO$	Off if $V_{VREG} < UVLO$	Low if $V_{VUC} < V_{VXX(UV,L)}$	Low	Off if $V_{VREG} < UVLO$	No effect	No effect	Connect the VREG pin
VREG shorted to ground $V_{VREG} < 1.95 V$ , $V_{COMP} \neq V_{O(IEA,MAX)}$	Continue to PWM but turn off LX when the high side MOSFET current exceeds $I_{LIM(LX)}$	No	No effect	No effect	No effect	Shorted	Off if $V_{VREG} < UVLO$	Off if $V_{VREG} < UVLO$	Off if $V_{VREG} < UVLO$	Off if $V_{VREG} < UVLO$	Off if $V_{VREG} < UVLO$	Low if $V_{VUC} < V_{VXX(UV,L)}$	Low	Off if $V_{VREG} < UVLO$	No effect	No effect	Remove the short circuit
VREG overcurrent $V_{VREG} < 1.95 V$ , $V_{COMP} = V_{O(IEA,MAX)}$	Enters hiccup mode after 30 OCP faults	No	No effect	No effect	No effect	Over-current	Off if $V_{VREG} < UVLO$	Off if $V_{VREG} < UVLO$	Off if $V_{VREG} < UVLO$	Off if $V_{VREG} < UVLO$	Off if $V_{VREG} < UVLO$	Low if $V_{VUC} < V_{VXX(UV,L)}$	Low	Off if $V_{VREG} < UVLO$	No effect	No effect	Decrease the load
VREG overcurrent $V_{VREG} > 1.95 V$ , $V_{COMP} = V_{O(IEA,MAX)}$	Enters hiccup mode after 120 OCP faults	No	No effect	No effect	No effect	Over-current	Off if $V_{VREG} < UVLO$	Off if $V_{VREG} < UVLO$	Off if $V_{VREG} < UVLO$	Off if $V_{VREG} < UVLO$	Off if $V_{VREG} < UVLO$	Low if $V_{VUC} < V_{VXX(UV,L)}$	Low	Low if $V_{VUC} < V_{VXX(UV,L)}$	No effect	No effect	Decrease the load
VUC undervoltage	Closed loop control will try to raise the voltage but may be constrained by the foldback or pulse-by-pulse current limit	No	No effect	No effect	No effect	No effect	$V_{VUC} < V_{VXX(UV,L)}$	No effect	No effect (Track to VUC)	No effect (Track to VUC)	Off	Low	Low	Low	No effect	No effect	Decrease the load
VUC overvoltage	If OV condition persists for more than $t_{OV}$ then set NPOR Low	No	No effect	No effect	No effect	No effect	$V_{VUC} > V_{VXX(OV,H)}$	No effect	No effect (Track to VUC)	No effect (Track to VUC)	Off	Low	Low	Low	No effect	No effect	Check for short circuits
VUC overcurrent	Foldback current limit will reduce the output voltage	No	No effect	No effect	No effect	No effect	Falling	No effect	No effect (Track to VUC)	No effect (Track to VUC)	Low if $V_{VUC} < V_{VXX(UV,L)}$	Low if $V_{VUC} < V_{VXX(UV,L)}$	Low if $V_{VUC} < V_{VXX(UV,L)}$	Low if $V_{VUC} < V_{VXX(UV,L)}$	No effect	No effect	Decrease the load
V5P1 undervoltage	Closed loop control will try to raise the voltage but may be constrained by the foldback current limit	No	No effect	No effect	No effect	No effect	No effect	No effect	$V_{V5P1} < V_{V5(UV,L)}$	No effect	No effect	No effect	Low	No effect	No effect	No effect	Decrease the load
V5P1 overvoltage or shorted to VBAT	If OV condition persists for more than $t_{OV}$ then set FFn Low	No	No effect	No effect	No effect	No effect	No effect	No effect	Off	No effect	No effect	No effect	Low	No effect	No effect	No effect	Check for short circuits on V5P1

Continued on next page...

# ARG82800

## Fully Integrated PMIC for Safety-Related Systems with Buck or Buck-Boost Pre-Regulator, 4× Linear Regulators, 4× Gate Drivers, and SPI

Table 2: Summary of Fault Mode Operation (continued)

FAULT TYPE and CONDITION	ARG82800 RESPONSE TO FAULT	LATCHED FAULT?	VCC	VCP1	VCP2	VREG	VUC	V5C	V5P1	V5P2	Isolator Drivers	NPOR	FFn	POE	SPI	WD	RESET METHOD
V5P1 overcurrent	Foldback current limit will reduce the output voltage	No	No effect	No effect	No effect	No effect	No effect	No effect	Falling	No effect	No effect	No effect	Low	No effect	No effect	No effect	Decrease the load
V5P2 undervoltage	Closed loop control will try to raise the voltage but may be constrained by the foldback current limit	No	No effect	No effect	No effect	No effect	No effect	No effect	No effect	$V_{V5P2} < V_{V5(UV,L)}$	No effect	No effect	Low	No effect	No effect	No effect	Decrease the load
V5P2 overvoltage or shorted to VBAT	If OV condition persists for more than $t_{d(OV)}$ then set FFn Low	No	No effect	No effect	No effect	No effect	No effect	No effect	No effect	Off	No effect	No effect	Low	No effect	No effect	No effect	Check for short circuits on V5P2
V5P2 overcurrent	Foldback current limit will reduce the output voltage	No	No effect	No effect	No effect	No effect	No effect	No effect	No effect	Falling	No effect	No effect	Low	No effect	No effect	No effect	Decrease the load
V5C overvoltage	If OV condition persists for more than $t_{d(OV)}$ then set FFn Low	No	No effect	No effect	No effect	No effect	No effect	$V_{V5C} > V_{V5(OV,H)}$	No effect	No effect	No effect	No effect	Low	No effect	No effect	No effect	Check for short circuits on V5C
V5C undervoltage	Closed loop control will try to raise the voltage but may be constrained by the foldback current limit	No	No effect	No effect	No effect	No effect	No effect	$V_{V5C} < V_{V5(UV,L)}$	No effect	No effect	No effect	No effect	Low	No effect	No effect	No effect	Decrease the load
V5C overcurrent	Foldback current limit will reduce the output voltage	No	No effect	No effect	No effect	No effect	No effect	Falling	No effect	No effect	No effect	No effect	Low	No effect	No effect	No effect	Decrease the load
Thermal shutdown	Results in an MPOR, so all regulators are shut off	No	No effect	No effect	No effect	Off	Off	Off	Off	Off	Off	Low	Low	Low	No effect	No effect	Let the ARG82800 cool
Window WD error	Put the system into a safe state	No	No effect	No effect	No effect	No effect	No effect	No effect	Off	Off	Off	Low (One shot)	Low	Low	No effect	-	Get proper signal from microcontroller
Q&A watchdog error	Put the system into a safe state	No	No effect	No effect	No effect	No effect	No effect	No effect	Off	Off	Off	Low (One shot)	Low	Low	No effect	-	Get proper signal from microcontroller
BIST error	Fault flag	No	No effect	No effect	No effect	No effect	No effect	No effect	No effect	No effect	Off	No effect	Low	Low	No effect	No effect	Write 1 to reset
SVBB_UV	Corresponding (GVBB) Isolator off	Yes	No effect	No effect	No effect	No effect	No effect	No effect	No effect	No effect	GVBB: off GU, GV, GW: No effect	No effect	Low	No effect	No effect	No effect	Check for short circuits on SVBB, Toggle ENVBB
SU_UV (see 0x09 [D7])	Corresponding (GU) Isolator off	Yes	No effect	No effect	No effect	No effect	No effect	No effect	No effect	No effect	GU: off GVBB, GV, GW: No effect	No effect	Low	No effect	No effect	No effect	Check for short circuits on SU, Toggle ENU and Write 1 to reset
GSx_UV	Fault flag	No	No effect	No effect	No effect	No effect	No effect	No effect	No effect	No effect	No effect	No effect	Low	No effect	No effect	No effect	Check for short circuits on Gx
LG operation failure	Fault flag	No	No effect	No effect	No effect	No effect	No effect	No effect	No effect	No effect	No effect	No effect	Low	No effect	No effect	No effect	Check for short circuits on LG
VDD_UV	Fault flag	No	No effect	No effect	No effect	No effect	No effect	No effect	No effect	No effect	No effect	No effect	Low	No effect	May lose contents	May have effect	Restart the device
DBE Fault	Fault flag	No	No effect	No effect	No effect	No effect	No effect	No effect	No effect	No effect	No effect	No effect	Low	No effect	No effect	No effect	Restart the device
SE Fault	Fault flag	No	No effect	No effect	No effect	No effect	No effect	No effect	No effect	No effect	No effect	No effect	Low	No effect	No effect	No effect	Check SPI signal

## FUNCTIONAL DESCRIPTION

### Overview

The ARG82800 is a power management IC designed for safety-critical applications. It contains one switching and four linear regulators to create the voltages necessary for typical automotive applications such as electrical power steering.

The ARG82800 pre-regulator can be configured as a buck converter or buck boost. Buck boost is suitable for when applications must work with extremely low battery voltages. This pre-regulator generates a fixed 5.35 V to power the internal or external post-regulators. These post-regulators generate the various voltage levels for the end system.

### Pre-Regulator

The pre-regulator incorporates an internal high-side buck switch and a boost switch gate driver. An external freewheeling diode and LC filter are required to complete the buck converter. By adding a MOSFET and boost diode, the pre-regulator can now maintain all outputs with input voltages down to 3.8 V.

The pre-regulator provides many protection and diagnostic functions:

1. Pulse-by-pulse and hiccup mode current limit
2. Undervoltage detection and reporting
3. Shorted switch node to ground
4. Open freewheeling diode protection
5. High voltage rating for load dump

### Bias Supply

The bias supply ( $V_{CC}$ ) is generated by an internal linear regulator. This supply is the first rail to start up. Most of the internal control circuitry is powered by this supply. The bias supply includes some unique features to ensure safe operation of the ARG82800. These features include:

1. Input voltage undervoltage lockout
2. Output undervoltage detection and reporting
3. Overcurrent and short-circuit limit
4. Dual input, VIN and VREG, for low battery voltage operation

### Charge Pump

Charge pump circuits provide the voltage necessary to drive high-side N-channel MOSFETs in the pre-regulator, linear regulators, and floating gate drivers. Four external capacitors are required for charge pump operation. During the first cycle of the charge pump

action, the flying capacitor between pins CP1C1 and CP1C2 is charged either from VIN or VREG, whichever is highest. During the second cycle, the voltage on the flying capacitor charges the VCP1 capacitor and the flying capacitor, between pins CP2C1 and CP2C2. During the next cycle, the voltage on the flying capacitor charges the VCP2 capacitor. The charge pump incorporates some safety features:

1. Undervoltage and overvoltage detection and reporting
2. Overcurrent safe mode protection

### Bandgap

Dual bandgaps are implemented within the ARG82800. One bandgap is dedicated to the voltage regulation loops within each of the regulators, VCC, VCPx, VREG, and the four post-regulators. The second is dedicated to the monitoring function of all the regulators undervoltage and overvoltage. This improves safety coverage and fault reporting from the ARG82800.

Should the regulation bandgap fail, then the outputs will be out of specification and the monitoring bandgap will report the fault.

If the monitoring bandgap fails, the outputs will remain in regulation, but the monitoring circuits will report the outputs as out of specification and trip the fault flag.

The bandgap circuits include two other bandgaps that are used to monitor the undervoltage state of the main bandgaps.

### Enable

Two Enable pins are available on the ARG82800. A high signal on either of these pins enables the regulated outputs of the ARG82800. One Enable (ENB) is logic-level compatible. The second enable (ENBAT), is battery-level rated and can be connected to the ignition switch.

### Linear Regulators

The ARG82800 has four linear regulators: one 5 V regulator, one 5 V or 3.3 V selectable regulator, and two protected regulators which track VUC (5 V or 3.3 V).

All linear regulators provide the following protection features:

1. Current limit with foldback
2. Undervoltage and overvoltage detection and reporting

The protected regulators (V5P1 and V5P2) include protection against connection to the battery voltage. This makes these outputs suitable for powering remote sensors or circuitry where short to battery is possible.

The pre-regulator powers these linear regulators which reduces power dissipation and temperature.

	VUCSEL	V <sub>OUT(TYP)</sub>	Startup	Tracking
VUC	1	5 V	When $V_{VREG} > V_{VREG(UV,H)}$	n/a
	0	3.3 V		
V5C	Don't Care	5 V	When $V_{VUC} > V_{V5} / V_{V33(UV,H)}$	n/a
V5Px	1	5 V	Enabled via SPI	VUC (DC level) During start-up it does not track VUC since default SPI bit is "disabled"
	0	3.3 V		

## Fault Detection and Reporting

There is extensive fault detection within the ARG82800; most have been discussed previously. There are two fault reporting mechanisms used by the ARG82800: one through hardwired pins and the other through a serial communications interface (SPI).

Two hardwired pins on the ARG82800 are used for fault reporting. The first pin, NPOR, reports on the status of the VUC output. This signal goes low if this output is out of regulation. The second pin, FFn (active low fault flag), reports on all other faults. FFn goes low if a fault within the ARG82800 exists. The FFn pin can be used by the processor as an alert to check the status of the ARG82800 via SPI and see where the fault occurred.

## Startup Self-Test

The ARG82800 includes self-test which is performed during the startup sequence. This self-test verifies the operation of the undervoltage and overvoltage detection circuits for the main outputs.

In the event the self-test fails, the ARG82800 will report the failure through SPI.

## Undervoltage Detect Self-Test

The undervoltage (UV) detectors are verified during startup of the ARG82800. A voltage that is higher than the undervoltage threshold is applied to each UV comparator; this should cause the relative undervoltage fault bit in the diagnostic registers to change state. If the diagnostic UV register bits change state, the corresponding verify register bits will latch high. When the test of all UV detectors is complete, the verify register bits will remain high if the test passed. If any UV bits in the verify registers, after test, are not set high, then the verification has failed. The following UV detectors are tested: VREG, VUC, V5C, V5P1, and V5P2.

## Overvoltage Detect Self-Test

The overvoltage (OV) detectors are verified during startup of the ARG82800. A voltage is applied to each OV comparator that is higher than the overvoltage threshold; this should cause the relative overvoltage fault bit in the diagnostic registers to change state. If the diagnostic OV register bits change state, the corresponding verify register bits will latch high. When the test of all OV detectors is complete, the verify register bits will remain high if the test passed. If any OV bits in the verify registers after test are not set high, then the verification has failed. The following OV detectors are tested: VREG, VUC, V5C, V5P1, and V5P2.

## Overtemperature Shutdown Self-Test

The overtemperature shutdown (TSD) detector is verified on startup of the ARG82800. A voltage is applied to the comparator that is lower than the overtemperature threshold and should cause the general fault flag to be active and an overtemperature fault bit, TSD, to be latched in the Verify Result register 0. When the test is complete, the general fault flag will be cleared and the overtemperature fault will remain in the Verify Result register 0 until reset. If the TSD bit is not set, then the verification has failed.

## Power-On Enable Self-Test

The ARG82800 also incorporates continuous self-testing of the power-on enable (POE) output. It compares the status of the POE pin with the internal demanded status. If they differ for any reason, an FFn is set and the POE\_OK in SPI diagnostic register goes low.

## Watchdog Timer

The ARG82800 has two watchdog functions: window watchdog timer and Q&A watchdog timer. When the regulators (VUC and V5C) have been above their undervoltage thresholds for watchdog activation delay ( $t_{d(WD)}$ ), WD is activated, WD state will be in the configuration state ("Config"), and the user can set the configuration within 220 ms (min,  $t_{WDTO(CONFIG)}$ ). If no configuration input until  $t_{WDTO(CONFIG)}$  is expired, WD moves into "RESET". Moving back to "Config" mode requires secure SPI command (0x0B).

## WINDOW WATCHDOG

The ARG82800 window watchdog circuit monitors an external clock applied to the WDIN pin. This clock should be generated by the microcontroller or DSP. The time between rising edges of the clock must fall within a SPI-programmed "window" or a watchdog fault will be generated. A watchdog fault will set NPOR and POE "low".

After startup, if no clock edges are detected at WDIN for watchdog activation delay  $t_{d(WD)} + \text{max timeout}$  (written in 0x09), the ARG82800 will generate watchdog fault and reset its counters. This process will repeat until the system recovers and clock edges are applied to WDIN.

## Q&A WATCHDOG

The Q&A watchdog circuit monitors an answer code from the microcontroller. The Q&A watchdog procedure is as follows:

1. Write 0x08 to set open window period and acceptable number of mis-refresh in “Config” mode.
2. Write 0x0B for watchdog restart. Then ARG82800 enters into “Normal” mode and generates 6-bit random code.
3. Microcontroller reads 0x0A to get 6-bit random code via SDO.
4. Write 0x0A with 6-bit inverted random code within open window period. In case the ARG82800 can’t get the right inverted code, then the watchdog timer is refreshed and generates new 6-bit random code. ARG82800 can accept mis-refresh.
5. Repeat #2 to #4 within the programmed window.

## Analog Multiplexer Output

The AMUXO terminal is an analog multiplexer output to monitor the voltage of the nodes detailed in Table 3. The output is selected through the serial interface (0x0C). The driving capability of this output is 1 mA and maximum voltage is 3.8 V. Reference response time from SPI register write to AMUX output change is ~20 μs.

**Table 3: Analog Multiplexer Output**

Node	Signal Divide Ratio	Tolerance (reference)
VREG	1/2	±6%
VUC	1/2	±6%
V5C	1/2	±6%
V5P1	1/2	±6%
V5P2	1/2	±6%
VENBAT	1/8	±6%
VCP1	1/12	±6%
VCP2	1/12	±6%
BG1	1/1	±6%
BG2	1/1	±6%
VIN	1/10	±6%
TEMP	–	Output (mV) = 1440 mV – 3.92 mV/°C × T <sub>J</sub> (°C)

**Table 4: Floating MOSFET Driver**

Name	GD_U_SEL (0x09 [D5])	Purpose	Enable/Disable		Gate to Source UV	Source to GND UV	
			Register Bit	Delay	State Register bit	Function	State Register bit
GVBB / SVBB	X (don't care)	VBAT disconnect	ENVBB (0x07 [D3])	1.5 ms	GSVBB_UV (0x02 [D7])	Yes	SVBB_UV (0x02 [D3])
GU / SU	0	Phase disconnect	ENU (0x07 [D2])	10 ms	GSU_UV (0x02 [D6])	No (Disabled)	SU_UV (0x02 [D2]) Always=0
	1	VBAT disconnect		1.5 ms		Yes	SU_UV (0x02 [D2])
GV / SV	X	Phase disconnect	ENV (0x07 [D1])	10 ms	GSV_UV (0x02 [D5])	No	–
GW / SW	X	Phase disconnect	ENW (0x07 [D0])	10 ms	GSW_UV (0x02 [D4])	No	–

## Floating MOSFET Gate Drivers

The ARG82800 has four independent floating gate drive outputs to drive external, low on-resistance, power N-channel MOSFETs connected as a 3-phase solid state relay in phase-isolation applications and an input battery line isolator.

A charge pump regulator provides the above-battery supply voltage necessary to maintain the power MOSFETs in the on state continuously when the phase voltage is equal to the battery voltage.

An internal resistor, R<sub>GPD</sub>, between the G<sub>x</sub> and S<sub>x</sub> pins plus an integrated hold-off circuit, will ensure that the gate-source voltage of the MOSFET is held close to 0 V even with the power disconnected. This can remove the need for additional gate-source resistors on the isolation MOSFETs. In any case, if gate-source resistors are mandatory for the application, then the pump regulator can provide sufficient current to maintain the MOSFET in the on state with a gate-source resistor as low as 100 kΩ.

The four gate drives can be controlled independently through the serial interface by setting the appropriate bit in the control register.

The floating gate-drive outputs for external N-channel MOSFETs are provided on pins GVBB, GU, GV, and GW. G<sub>x</sub>=1 (or “high”) means that the upper half of the driver is turned on and current will be sourced to the gate of the MOSFET in the phase isolation circuit, turning it on. G<sub>x</sub>=0 (or “low”) means that the lower half of the driver is turned on and will sink current from the external MOSFET’s gate to the respective S<sub>x</sub> terminal, turning it off.

The reference points for the floating drives are the load phase connections, SVBB, SU, SV, and SW. The discharge current from the floating MOSFET gate capacitance flows through these connections.

In some applications, it may be necessary to provide a current recirculation path when the motor load is isolated. This will be necessary in situations where the motor driver does not reduce the load current to zero before the isolation MOSFETs are turned off.

The recirculation path can be provided by connecting a suitably rated power diode to the “motor” side of the isolation MOSFETs and GND. See the Functional Block Diagram for more details.

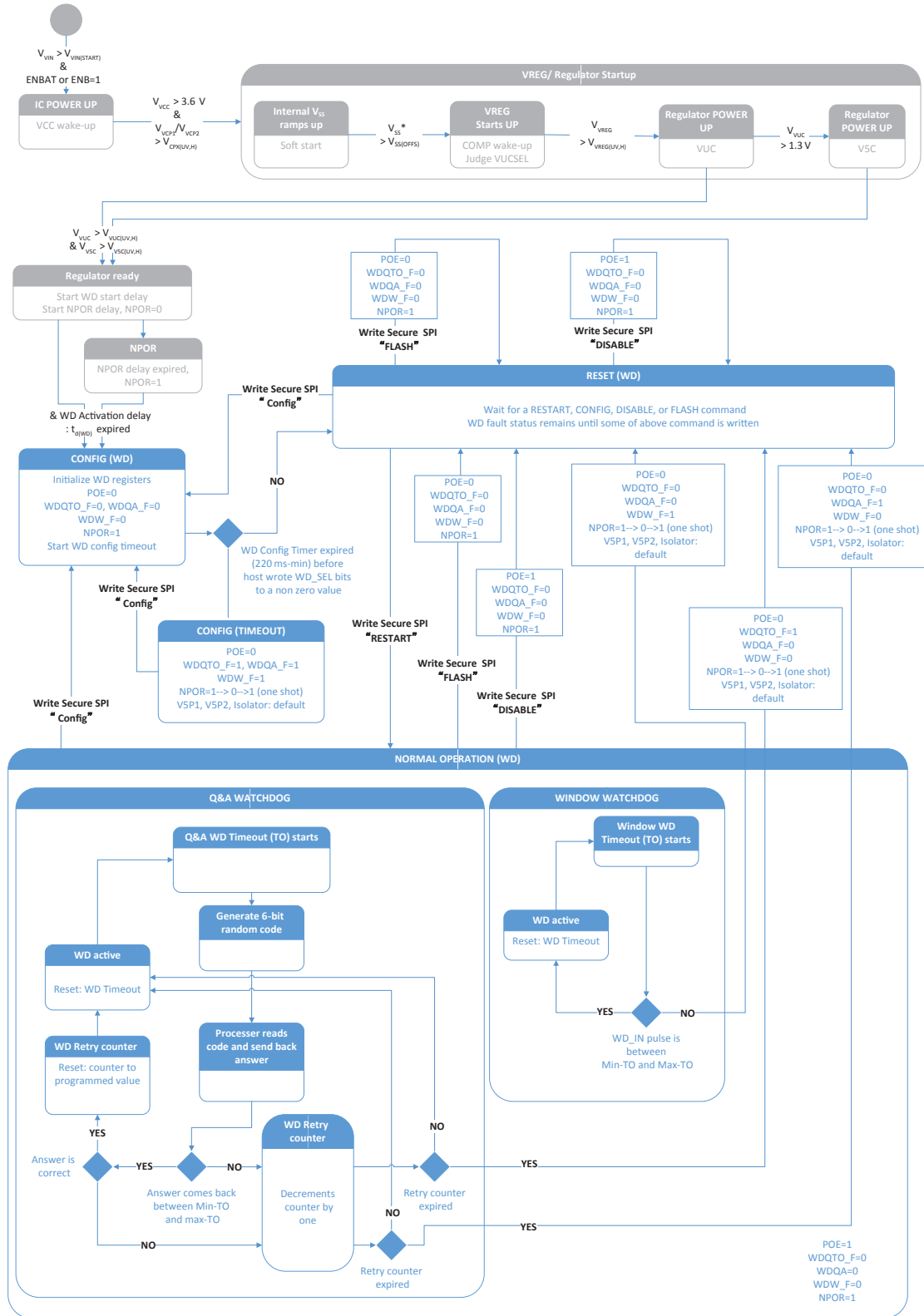


Figure 6: Watchdog State Diagram



## SERIAL COMMUNICATION INTERFACE

The ARG82800 provides the user with a three-wire synchronous serial interface that is compatible with SPI (Serial Peripheral Interface). A fourth wire can be used to provide diagnostic feedback and readback of the register content.

The serial interface timing requirements are specified in the Electrical Characteristics table and illustrated in the Serial Interface Timing diagram (Figure 1). Data is received on the SDI terminal and clocked through a shift register on the rising edge of the clock signal input on the SCK terminal. STRn is normally held high, and is only brought low to initiate a serial transfer. No data is clocked through the shift register when STRn is high, allowing multiple SDI slave units to use common SDI, SCK, and SDO connections. Each slave then requires an independent STRn connection.

When 16 data bits have been clocked into the shift register, STRn must be taken high to latch the data into the selected register. When this occurs, the internal control circuits act on the new data and the Diagnostic register is reset.

If there are more than 16 rising edges on SCK or if STRn goes high and there are fewer than 16 rising edges on SCK, the write will be cancelled without writing data to the registers. In addition, the Diagnostic register will not be reset and the SE (serial error) bit will be set to indicate a data transfer error.

Diagnostic information or the contents of the configuration and control registers is output on the SDO terminal MSB first while STRn is low, and changes to the next bit on each falling edge of SCK. The first bit, which is always the FF (fault flag) bit from the Diagnostic register, is output as soon as STRn goes low.

Each of the programmable (configuration and control) registers has a write bit, WR (bit 10), as the first bit after the register address. This bit must be set to 1 to write the subsequent bits into the selected register. If WR is set to 0, then the remaining data bits (bits 9 to 0) are ignored. The state of the WR bit also determines the data output on SDO. If WR is set to 1, then the Diagnostic register is output. If WR is set to 0, then the contents of the register selected by the first five bits is output. In all cases, the first bit output on SDO will always be the FF bit from the Diagnostic Register.

The ARG82800 has 15 register banks. Bit <15:11> represents the register address for read and write. Bit <10> detects the read and write operation. For write operation, Bit <10> = 1, and for read operation, bit value is logic low. Bit <9> is an unused bit. Maximum data size is eight bits, so Bit <8:1> represents the data word. The last bit in the serial transfer, Bit <0> is parity bit that is set to ensure odd parity in the complete 16-bit word. Odd parity means that the total number of 1s in any transmission should always be an odd number. This ensures that there is always at least one bit

### Pattern at SDI Pin

MSB															LSB
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
A4	A3	A2	A1	A0	W/R	NU	D7	D6	D5	D4	D3	D2	D1	D0	P
5-Bit Address							8-Bit Data								

### Pattern at SDO Pin after SDI Write

MSB															LSB
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
DBE	FF	SE	ENBATS	WDW_F	WDQTO_F	WDQA_F	VREG_OK	VCC_OK	VCP_OK	VUC_OK	V5C_OK	0	0	0	P
Diagnostics															

### Pattern at SDO Pin after SDI Read

MSB															LSB
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
DBE	FF	SE	ENBATS	WDW_F	WDQTO_F	WDQA_F	D7	D6	D5	D4	D3	D2	D1	D0	P
Diagnostics							8-Bit Data								

set to 1 and one bit set to 0 and allows detection of stuck-at faults on the serial input and output data connections. The parity bit is not stored but generated on each transfer.

Register data is output on the SDO terminal MSB first while STRn is low and changes to the next bit on each falling edge of the SCK. The first bit, which is always the FF bit from the status register, is output as soon as STRn goes low.

If there are more than 16 rising edges on SCL or if STRn goes high and there are fewer than 16 rising edges on SCK, the write will be cancelled without writing data to the registers. In addition, the diagnostic register will not be reset the SE bit will be set to indicate a data transfer error.

**SDI:** Serial data logic input with pull down. 16-bit serial word input MSB first.

**SCK:** Serial clock logic input with pull-down. Data is latched in from SDI on the rising edge of SCL. There must be 16 rising edges per write and SCK must be held high when STRn changes.

**STRn:** Serial data strobe and serial access enable logic input with pull-up. When STRn is high, any activity on SCK or SDI is ignored and SDO is high impedance, allowing multiple SDI slaves to have common SDI, SCK, and SDO connections.

**SDO:** Serial data output. High impedance when STRn is high. Output bit 15 of the status register, the fault flag (FF) as soon as STRn goes low.

## Register Mapping

### STATUS REGISTERS

The ARG82800 provides four status registers. These registers are read only. They provide real-time status of various functions within the ARG82800.

These registers report on the status of all four system rails. They also report on internal rail status, including the charge pump, VREG, and VCC rails. The general fault flag and watchdog fault state are found in these status registers.

The logic that creates the power-on enable and power reset status are reported through these registers.

### CONFIGURATION REGISTERS

The ARG82800 allows configuration of the watchdog validation parameters and disabling dithering function.

The watchdog can only be configured during “Config” state. This occurs when the ARG82800 is initially enabled or the watchdog is restarted through SPI.

The ARG82800 uses frequency dithering for pre-regulator to help reduce EMC noise. The user can disable this feature through the SPI. Default is enabled.

All WD Configuration must be entered before modifying the WD\_SEL bits, meaning Config\_1 must be written before Config\_0.

### DIAGNOSTIC REGISTERS

There are multiple diagnostic registers in the ARG82800. These registers can be read to evaluate the status of the ARG82800. The high-level registers will indicate which area a fault has occurred. Logic high on a data bit in this register implies that no fault has occurred. The following are monitored by these registers:

- All four outputs
- ARG82800 bias voltage
- Charge pump voltage
- Pre-regulator voltage
- Overtemperature
- Watchdog output
- Shorts on LX pin or open diode on pre-regulator

Note some of these faults will cause the ARG82800 to shut down, which might shutdown the microprocessor monitoring the SPI. In this event, the only way to read the fault would be to have alternative power to the microprocessor so it can read the registers. If V<sub>CC</sub> of the ARG82800 shuts down, all stored register information is lost and the registers revert back to default values.

Other diagnostic registers store more details on each fault, this includes:

- Overvoltage on a particular output or internal rail
- Undervoltage on a particular output or internal rail

The diagnostic registers are latch registers and will hold data if a fault has occurred but recovered. These registers are reset by writing a 1 to them.

### OUTPUT ENABLE/DISABLE REGISTER

The output enable/disable register provides the user control of the LDO outputs and isolator drivers. For LDO control, two bits must be set high to enable an output. If only one bit is high, then the 5 V outputs remain off.

### WATCHDOG MODE KEY REGISTER

At times, it may be necessary to re-flash or restart the processor. To do this, the user must put the watchdog into “Flash Mode” or “restart”. This is done by writing a sequence of key words to the “watchdog\_mode\_key” register. If the correct word sequence is not received, then the sequence must restart.

Once flash is complete, the processor must send the restart sequence of keywords for the watchdog to exit “Flash Mode”. If V<sub>CC</sub> has not been removed from the ARG82800, the watchdog will restart with the current configuration.

## VERIFY RESULT REGISTERS

On every startup, the ARG82800 performs a self-test of the UV and OV detect circuits. This test should cause the diagnostic registers to toggle state. If the diagnostic register successfully changes state, the verify result register will latch high. Upon completion of startup, the system’s microprocessor can check the verify result registers to see if the self-test passed.

**Table 5: Register Map**

HEX Address	Register Name	DEC Address	Type	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
0x00	status_0	0	RO	FF	POE_OK	SE	NPOR_S	NPOR_OK	WDW_F	WDQTO_F	WDQA_F
0x01	status_1	1	RO		VCC_OK	VCP_OK	VREG_OK	VUC_OK	V5C_OK	V5P1_OK	V5P2_OK
0x02	status_2	2	RO	GSVBB_UV	GSU_UV	GSV_UV	GSW_UV	SVBB_UV		POE_S	ENBAT_S
			RW1C					SU_UV			
0x03	status_3	3	RO	CLK_ST_H	CLK_ST_L	ENB_S	DBE	TSD_OK	LG_OK	LX_OK	D1_OK
0x04	diag_0	4	RW1C			VDD_UV	VCC_UV	VCP_OV	VCP_UV	V5P2_OV	V5P2_UV
0x05	diag_1	5	RW1C	VREG_OV	VREG_UV	VUC_OV	VUC_UV	V5C_OV	V5C_UV	V5P1_OV	V5P1_UV
0x06	output_enable / disable_0	6	RW				V5P1_EN1	V5P2_EN1		V5P1_EN0	V5P2_EN0
0x07	output_enable / disable_1	7	RW					ENVBB	ENU	ENV	ENW
0x08	config_0	8	RW	WD_SEL_1	WD_SEL_0	TRY_1	TRY_0	TIMER_3	TIMER_2	TIMER_1	TIMER_0
0x09	config_1	9	RW			GD_U_SEL	FFn_SEL	WIN_Timer_2	WIN_Timer_1	WIN_Timer_0	DITH_DIS
0x0A	Q&A Watchdog	10	RW			RND_5	RND_4	RND_3	RND_2	RND_1	RND_0
0x0B	Watchdog_Secure_key	11	WO	Keycode entry (White only)							
0x0C	AMUXOUT	12	RW					SEL_MUX_3	SEL_MUX_2	SEL_MUX_1	SEL_MUX_0
0x0D	Verify_result_0	13	RW1C	BIST_FAIL	TSD_FAIL	VREG_OV_FAIL	VREG_UV_FAIL	VUC_OV_FAIL	VUC_UV_FAIL	V5C_OV_FAIL	V5C_UV_FAIL
0x0E	Verify_result_1	14	RW1C					V5P1_OV_FAIL	V5P1_UV_FAIL	V5P2_OV_FAIL	V5P2_UV_FAIL

**Register Types:**  
 RO = Read-Only  
 RW = Read or Write  
 RW1C = Read or Write 1 to clear  
 WO = Write-Only

## 0x00: STATUS REGISTER 0

Status_0	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	5-bit Address					Type	NU	8-bit Data								P
	A4	A3	A2	A1	A0			D7	D6	D5	D4	D3	D2	D1	D0	
0	0	0	0	0	RO	0	FF	POE_OK	SE	NPOR_S	NPOR_OK	WDW_F	WDQTO_F	WDQA_F	0	0

<b>FF</b>	<b>Fault Flag</b>	
0	No Fault	Default
1	Fault	

<b>POE_OK</b>	<b>Power-on enable signal matches what ARG82800 is demanding</b>	
0	Fault	Default
1	No Fault	

<b>SE</b>	<b>Serial Error Flag [1]</b>	
0	No Fault	Default
1	Fault	

<b>NPOR_S</b>	<b>Power-On Reset Internal Logic Status</b>	
0	NPOR is Low	Default
1	NPOR is High	

<b>NPOR_OK</b>	<b>NPOR Signal matches what device is demanding</b>	
0	Fault	Default
1	No Fault	

<b>WDW_F</b>	<b>Window Watchdog Fault Flag</b>	
0	No Fault or Window Watchdog is disabled	Default
1	Fault	

<b>WDQTO_F</b>	<b>Q&amp;A Watchdog Timeout Fault Flag</b>	
0	Q&A watchdog off or No fault	Default
1	Q&A watchdog Timeout fault	

<b>WDQA_F</b>	<b>Q&amp;A Watchdog Answer Fault Flag</b>	
0	Q&A watchdog off or No fault	Default
1	Q&A watchdog Answer fault	

[1] SE Fault: If more than sixteen rising edges on SCK are detected while STRn is LOW or if STRn goes HIGH and there are fewer than sixteen rising edges on SCK.

## 0x01: STATUS REGISTER 1

Status_1	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	5-bit Address					Type	NU	8-bit Data								P
	A4	A3	A2	A1	A0			D7	D6	D5	D4	D3	D2	D1	D0	
0	0	0	0	1	RO	0	0	VCC_OK	VCP_OK	VREG_OK	VUC_OK	V5C_OK	V5P1_OK	V5P2_OK	0	0

<b>VCC_OK</b>	<b>VCC Output Rail is OK</b>	
0	Fault (UV)	Default
1	No Fault	

<b>VCP_OK</b>	<b>Charge Pump Output Rail is OK</b>	
0	Fault (VCP1-UV, VCP1-OV or VCP2-UV)	Default
1	No Fault	

<b>VREG_OK</b>	<b>VREG Output Rail is OK</b>	
0	Fault (UV or OV)	Default
1	No Fault	

<b>VUC_OK</b>	<b>VUC Output Rail is OK</b>	
0	Fault (UV or OV)	Default
1	No Fault	

<b>V5C_OK</b>	<b>V5C Output Rail is OK</b>	
0	Fault (UV or OV)	Default
1	No Fault	

<b>V5P1_OK</b>	<b>V5P1 Output Rail is OK</b>	
0	Fault (UV or OV)	Default
1	No Fault	

<b>V5P2_OK</b>	<b>V5P2 Output Rail is OK</b>	
0	Fault (UV or OV)	Default
1	No Fault	

## 0x02: STATUS REGISTER 2

Status_2	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	5-bit Address					Type	NU	8-bit Data								P
	A4	A3	A2	A1	A0	RO		D7	D6	D5	D4	D3	D2	D1	D0	
0	0	0	0	1	0	RW1C		GSVBB_UV	GSU_UV	GSV_UV	GSW_UV	SVBB_UV		POE_S	ENBAT_S	
							0	0	0	0	0	0	0	0	0	0

GSVBB_UV	GVBB - SVBB Undervoltage Status	
0	OK (Undervoltage is NOT detected or ENVBB=0)	Default
1	Undervoltage	

GSU_UV	GU - SU Undervoltage Status	
0	OK (Undervoltage is NOT detected or ENU=0)	Default
1	Undervoltage	

GSV_UV	GV - SV Undervoltage Status	
0	OK (Undervoltage is NOT detected or ENV=0)	Default
1	Undervoltage	

GSW_UV	GW - SW Undervoltage Status	
0	OK (Undervoltage is NOT detected or ENW=0)	Default
1	Undervoltage	

SVBB_UV	SVBB - GND Undervoltage Status	
0	OK (Undervoltage is NOT detected)	Default
1	Undervoltage	

SU_UV	SVBB - GND Undervoltage Status	
0	OK (Undervoltage is NOT detected or GD_U_SEL=0)	Default
1	Undervoltage (GD_U_SEL=1)	

POE_S	Power-On Enable Internal Logic Status	
0	POE is Low	Default
1	POE is High	

ENBAT_S	Battery Enable (ENBAT) Status	
0	ENBAT is Low	Default
1	ENBAT is High	

## 0x03: STATUS REGISTER 3

Status_3	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	5-bit Address					Type	NU	8-bit Data								P
	A4	A3	A2	A1	A0	RO		D7	D6	D5	D4	D3	D2	D1	D0	
0	0	0	0	1	1		0	CLK_ST_H	CLK_ST_L	ENB_S	DBE	TSD_OK	LG_OK	LX_OK	D1_OK	
							0	0	0	0	0	0	0	0	0	

CLK_ST_H	Indicates the internal clock is stuck high	
0	Internal Clock is not stuck high	Default
1	Internal Clock is stuck high	

CLK_ST_L	Indicates the internal clock is stuck low	
0	Internal Clock is not stuck Low	Default
1	Internal Clock is stuck Low	

ENB_S	Logic Enable (ENB) Status	
0	ENB is low	Default
1	ENB is high	

DBE	EEPROM Dual Bit Error Flag <sup>[1]</sup>	
0	No Fault	Default
1	Fault	

TSD_OK	Thermal Shutdown (Overttemperature) Detection Flag	
0	Overttemperature is detected	Default
1	OK (Overttemperature is NOT detected)	

LG_OK	Pre-Regulator Boost Gate Drive Output (LG) Status	
0	Fault on LG is detected	Default
1	OK (LG is working correctly)	

LX_OK	Pre-Regulator SW-Node (LX) Fault Detection Flag	
0	Fault on LX is detected	Default
1	OK (LX is working correctly)	

D1_OK	Pre-Regulator Asynchronous Diode (D1) Missing Detection Status	
0	Fault (D1 missing is detected)	Default
1	OK (D1 missing is NOT detected)	

<sup>[1]</sup> DBE Fault: it means that a dual bit error occurred loading the trim data from EEPROM.

## 0x04: DIAG REGISTER 0

Diag_0	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	5-bit Address					Type	NU	8-bit Data								
	A4	A3	A2	A1	A0			D7	D6	D5	D4	D3	D2	D1	D0	
0	0	1	0	0	RW1C			VDD_UV	VCC_UV	VCP_OV	VCP_UV	V5P2_OV	V5P2_UV			P
							0	0	0	0	0	0	0	0	0	

<b>VDD_UV</b>	<b>VDD Output Undervoltage Detection</b>	
0	OK (Undervoltage is NOT detected)	Default
1	Undervoltage is detected	

<b>VCC_UV</b>	<b>VCC Output Undervoltage Detection</b>	
0	OK (Undervoltage is NOT detected)	Default
1	Undervoltage is detected	

<b>VCP_OV</b>	<b>VCP Output Overvoltage Detection</b>	
0	OK (VCP1 Overvoltage is NOT detected)	Default
1	VCP1 Overvoltage is detected	

<b>VCP_UV</b>	<b>VCP Output Undervoltage Detection</b>	
0	OK (VCP1 and VCP2 Undervoltage is NOT detected)	Default
1	VCP1 or VCP2 Undervoltage is detected	

<b>V5P2_OV</b>	<b>V5P2 Output Overvoltage Detection</b>	
0	OK (Overvoltage is NOT detected)	Default
1	Overvoltage is detected	

<b>VR5P2_UV</b>	<b>V5P2 Rail Over Undervoltage Detection</b>	
0	OK (Undervoltage is NOT detected)	Default
1	Undervoltage is detected	

## 0x05: DIAG REGISTER 1

Diag_1	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	5-bit Address					Type	NU	8-bit Data								
	A4	A3	A2	A1	A0			D7	D6	D5	D4	D3	D2	D1	D0	
0	0	1	0	1	RW1C			VREG_OV	VREG_UV	VUC_OV	VUC_UV	V5C_OV	V5C_UV	V5P1_OV	V5P1_UV	P
							0	0	0	0	0	0	0	0	0	

<b>VREG_OV</b>	<b>VREG Output Overvoltage Detection</b>	
0	OK (Overvoltage is NOT detected)	Default
1	Overvoltage is detected	

<b>VREG_UV</b>	<b>VREG Output Undervoltage Detection</b>	
0	OK (Undervoltage is NOT detected)	Default
1	Undervoltage is detected	

<b>VUC_OV</b>	<b>VUC Output Overvoltage Detection</b>	
0	OK (Overvoltage is NOT detected)	Default
1	Overvoltage is detected	

<b>VUC_UV</b>	<b>VUC Output Undervoltage Detection</b>	
0	OK (Undervoltage is NOT detected)	Default
1	Undervoltage is detected	

<b>V5C_OV</b>	<b>V5C Output Overvoltage Detection</b>	
0	OK (Overvoltage is NOT detected)	Default
1	Overvoltage is detected	

<b>V5C_UV</b>	<b>V5C Output Undervoltage Detection</b>	
0	OK (Undervoltage is NOT detected)	Default
1	Undervoltage is detected	

<b>V5P1_OV</b>	<b>V5P1 Output Overvoltage Detection</b>	
0	OK (Overvoltage is NOT detected)	Default
1	Overvoltage is detected	

<b>V5P1_UV</b>	<b>V5P1 Output Undervoltage Detection</b>	
0	OK (Undervoltage is NOT detected)	Default
1	Undervoltage is detected	

## 0x06: OUTPUT ENABLE/DISABLE REGISTER 0

Output Enable/Disable Register_0	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	5-bit Address					Type	NU	8-bit Data								
	A4	A3	A2	A1	A0			D7	D6	D5	D4	D3	D2	D1	D0	
	0	0	1	1	0	RW				V5P1_EN1	V5P2_EN1		V5P1_EN0	V5P2_EN0	P	
					0	0	0	0	0	0	0	0	0			

V5P1_EN1	V5P1_EN0	Enable V5P1	
0	0	V5P1 is Disabled	Default
0	1	V5P1 is Disabled	
1	0	V5P1 is Disabled	
1	1	V5P1 is Enabled	

V5P2_EN1	V5P2_EN0	Enable V5P2	
0	0	V5P2 is Disabled	Default
0	1	V5P2 is Disabled	
1	0	V5P2 is Disabled	
1	1	V5P2 is Enabled	

## 0x07: OUTPUT ENABLE/ DISABLE REGISTER 1

Output Enable/Disable Register_1	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	5-bit Address					Type	NU	8-bit Data								
	A4	A3	A2	A1	A0			D7	D6	D5	D4	D3	D2	D1	D0	
	0	0	1	1	1	RW						ENVBB	ENU	ENV	ENW	P
					0	0	0	0	0	0	0	0	0	0		

ENVBB	Enable GVBB-Gate driver	
0	Disabled	Default
1	Enabled	

ENU	Enable GU-Gate driver	
0	Disabled	Default
1	Enabled	

ENV	Enable GV-Gate driver	
0	Disabled	Default
1	Enabled	

ENW	Enable GW-Gate driver	
0	Disabled	Default
1	Enabled	

## 0x08: CONFIGURATION REGISTER 0

Config_0	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	5-bit Address					Type	NU	8-bit Data								
	A4	A3	A2	A1	A0			D7	D6	D5	D4	D3	D2	D1	D0	
	0	1	0	0	0	RW	WD_SEL_1	WD_SEL_0	TRY_1	TRY_0	TIMER_3	TIMER_2	TIMER_1	TIMER_0	P	

WD_SEL_1	WD_SEL_0	Watchdog	
0	0	Default (WD waiting for config)	Default
0	1	Window watchdog only	
1	0	Q&A watchdog only	
1	1	Both (Window and Q&A)	

TRY_1	TRY_0	Acceptable Number of Mis-Refresh	
0	0	0	Default
0	1	1 time	
1	0	3 times	
1	1	7 times	

Timer3	Timer2	Timer1	Timer0	Min. Timeout [1]	Max. Timeout [1]	
0	0	0	0	0.5 ms	1 ms	Default
0	0	0	1	1 ms	2 ms	
0	0	1	0	2 ms	4 ms	
0	0	1	1	4 ms	8 ms	
0	1	0	0	8 ms	16 ms	
0	1	0	1	12 ms	24 ms	
0	1	1	0	16 ms	32 ms	
0	1	1	1	24 ms	48 ms	
1	0	0	0	32 ms	64 ms	
1	0	0	1	40 ms	80 ms	
1	0	1	0	64 ms	128 ms	
1	0	1	1	72 ms	144 ms	
1	1	0	0	80 ms	160 ms	
1	1	0	1	96 ms	192 ms	
1	1	1	0	128 ms	256 ms	
1	1	1	1	144 ms	288 ms	

[1] Typical number at the internal clock is center value, need to keep enough margin for ±5% tolerance of the clock.



## 0x09: CONFIGURATION REGISTER 1

Config_1	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	5-bit Address					Type	NU	8-bit Data								
	A4	A3	A2	A1	A0			D7	D6	D5	D4	D3	D2	D1	D0	
0	1	0	0	1	RW					GD_U_SEL	FFn_SEL	WIN_Timer_2	WIN_Timer_1	WIN_Timer_0	DITH_DIS	P
						0	0	0	0	0	0	0	0	0	0	

GD_U_SEL	Select Gate Drive GU/SU Node Function			Note
	ENU Gate Driver Enable/Disable Delay (typ)	SU-JV		
0	10 ms	Disabled		GU/SU is used for phase isolator Default
1	1.5 ms	Enabled		GU/SU is used for VBAT disconnect

FFn_SEL	Signal on FFn Pin	
0	Fault-Low	Default
1	50 Hz (Nominal) clock signal output; independent from fault flag	

WIN_Timer_2	WIN_Timer_1	WIN_Timer_0	Window Watchdog Error Timeout (Min.) <sup>[1]</sup>	Window Watchdog Error Timeout (Max.) <sup>[1]</sup>	
0	0	0	0.5 ms	4 ms	Default
0	0	1	1 ms	8 ms	
0	1	0	2 ms	16 ms	
0	1	1	4 ms	32 ms	
1	0	0	6 ms	42 ms	
1	0	1	8 ms	64 ms	
1	1	0	10 ms	80 ms	
1	1	1	12.5 ms	100 ms	

<sup>[1]</sup> Typical number at the internal clock is center value, need to keep enough margin for ±5% tolerance of the clock.

DITH_DIS	Disable Dithering Function	
0	Dithering is enabled	Default
1	Dithering is disabled	

## 0x0A: Q&A WATCHDOG REGISTER

	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Q&A WD	0	1	0	1	0	RW				RND_5	RND_4	RND_3	RND_2	RND_1	RND_0	P
							0	0	0	0	0	0	0	0	0	

## 0x0B: WATCHDOG SECURE KEY REGISTER

	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
WD Secure Key	0	1	0	1	1	WO		KEY_7	KEY_6	KEY_5	KEY_4	KEY_3	KEY_2	KEY_1	KEY_0	P
							0	0	0	0	0	0	0	0	0	

Three 8-bit words must be sent in the correct order to enable flash mode, config mode, Watchdog restart, or disable the watchdog for debugging purpose. If an incorrect word is received, then the register resets and the first word has to be resent.

	Flash Mode	Config Mode	Watchdog Restart	Watchdog Disable
WORD1	0xD3	0xD3	0xD3	0xD3
WORD2	0x33	0x33	0x33	0x33
WORD3	0xCC	0xCD	0xCE	0xCF

## 0x0C: ANALOG MUX OUTPUT REGISTER

	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
AMUXOUT	0	1	1	0	0	RW						SEL_MUX_3	SEL_MUX_2	SEL_MUX_1	SEL_MUX_0	P
							0	0	0	0	0	0	0	0	0	

SEL_MUX_3	SEL_MUX_2	SEL_MUX_1	SEL_MUX_0	MUX Output (Signal Divided Ratio)	Default
0	0	0	0	VREG (1/2)	Default
0	0	0	1	VUC (1/2)	
0	0	1	0	V5C (1/2)	
0	0	1	1	V5P1 (1/2)	
0	1	0	0	V5P2 (1/2)	
0	1	0	1	ENBAT (1/8)	
0	1	1	0	BG1 (1/1)	
0	1	1	1	BG2 (1/1)	
1	0	0	0	TEMP (n/a) Output (mV) = 1440 mV – 3.92 mV/°C × T <sub>J</sub> (°C)	
1	0	0	1	VIN (1/10)	
1	0	1	0	VCP1 (1/12)	
1	0	1	1	VCP2 (1/12)	

## 0x0D: VERIFY REGISTER 0

Verify_0	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	5-bit Address					Type	NU	8-bit Data								
	A4	A3	A2	A1	A0			D7	D6	D5	D4	D3	D2	D1	D0	
	0	1	1	0	1	RW1C	BIST_FAIL	TSD_FAIL	VREG_OV_FAIL	VREG_UV_FAIL	VUC_OV_FAIL	VUC_UV_FAIL	V5C_OV_FAIL	V5C_UV_FAIL		
						0	0	0	0	0	0	0	0	0	0	

<b>BIST_FAIL</b>	<b>Built-In Self-Test Result Flag</b>	
0	Self-test passed	Default
1	Self-test failed	

<b>TSD_FAIL</b>	<b>Thermal Shutdown Self-Test Result Flag</b>	
0	Self-test passed	Default
1	Self-test failed	

<b>VREG_OV_FAIL</b>	<b>VREG Overvoltage Self-Test Result Flag</b>	
0	Self-test passed	Default
1	Self-test failed	

<b>VREG_UV_FAIL</b>	<b>VREG Undervoltage Self-Test Result Flag</b>	
0	Self-test passed	Default
1	Self-test failed	

<b>VUC_OV_FAIL</b>	<b>VUC Overvoltage Self-Test Result Flag</b>	
0	Self-test passed	Default
1	Self-test failed	

<b>VUC_UV_FAIL</b>	<b>VUC Undervoltage Self-Test Result Flag</b>	
0	Self-test passed	Default
1	Self-test failed	

<b>V5C_OV_FAIL</b>	<b>V5C Overvoltage Self-Test Result Flag</b>	
0	Self-test passed	Default
1	Self-test failed	

<b>V5C_UV_FAIL</b>	<b>V5C Undervoltage Self-Test Result Flag</b>	
0	Self-test passed	Default
1	Self-test failed	

## 0x0E: VERIFY REGISTER 1

Verify_1	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	
	0	1	1	1	0	RW1C						V5P1_OV_FAIL	V5P1_UV_FAIL	V5P2_OV_FAIL	V5P2_UV_FAIL		
							0	0	0	0	0	0	0	0	0	0	

<b>V5P1_OV_FAIL</b>	<b>V5P1 Overvoltage Self-Test Result Flag</b>	
0	Self-test passed	Default
1	Self-test failed	

<b>V5P1_UV_FAIL</b>	<b>V5P1 Undervoltage Self-Test Result Flag</b>	
0	Self-test passed	Default
1	Self-test failed	

<b>V5P2_OV_FAIL</b>	<b>V5P2 Overvoltage Self-Test Result Flag</b>	
0	Self-test passed	Default
1	Self-test failed	

<b>V5P2_UV_FAIL</b>	<b>V5P2 Undervoltage Self-Test Result Flag</b>	
0	Self-test passed	Default
1	Self-test failed	

## DESIGN AND COMPONENT SELECTION

The following section briefly describes the component selection procedure for the ARG82800.

### Setting up the Pre-Regulator

This section discusses the component selection for the ARG82800 pre-regulator. It covers the charge pump circuit, inductor, diodes, boost MOSFET, and input and output capacitors. It will also cover loop compensation.

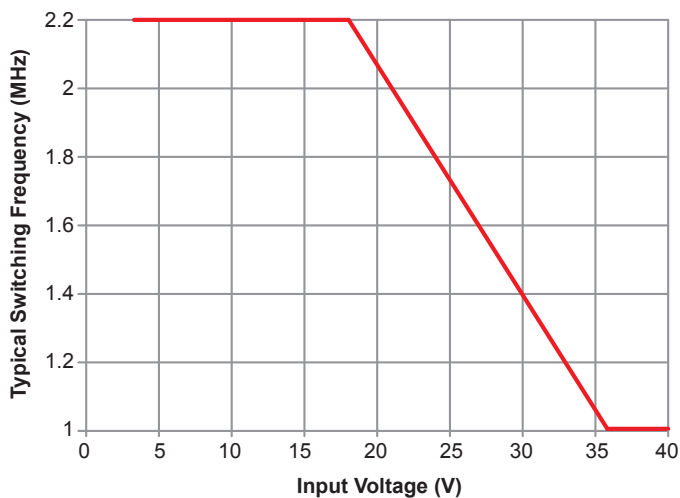
### Charge Pump Capacitors

The charge pump circuits require two capacitors: VCP1, a 2.2 μF connected from pin VCP1 to VIN and 1 μF connected between pins CP1C1 and CP1C2; and VCP2, a 1 μF connected from pin VCP2 to VCP1 and 0.22 μF connected between pins CP2C1 and CP2C2. These capacitors should be high-quality ceramic capacitors, such as an X5R or X7R, with a voltage rating of at least 16 V.

### PWM Switching Frequency

The switching frequency of the ARG82800 is fixed at 2.2 MHz nominal. The ARG82800 includes a frequency foldback scheme that starts when  $V_{IN}$  is greater than 18 V. Between 18 V and 36 V, the switching frequency will foldback from 2.2 MHz typical to 1 MHz typical. The switching frequency for a given input voltage above 18 V and below 36 V is:

$$f_{sw} = 3.4 - \frac{1.2}{18} \times V_{VIN} \text{ (MHz)} \quad (1)$$



**Figure 7: Typical Switching Frequency versus Input Voltage**

### Pre-Regulator Output Inductor

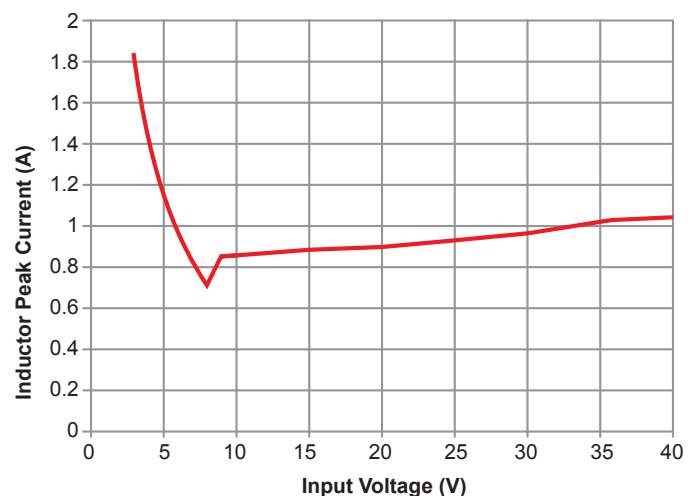
For peak current-mode control, it is well known that the system will become unstable when the duty cycle is above 50% without adequate Slope Compensation ( $S_E$ ). However, the slope compensation in the ARG82800 is a fixed value. Therefore, it is important to calculate an inductor value so the falling slope of the inductor current ( $S_F$ ) will work well with the ARG82800's slope compensation.

Equation 2 can be used to calculate a range of values for the output inductor for the buck-boost. In equation 2, slope compensation can be found in the Electrical Characteristic table,  $V_F$  is the asynchronous diode's forward voltage,  $S_E$  is in A/μs, and L will be in μH:

$$\frac{(V_{VREG} + V_F)}{S_E} \leq L \leq \frac{2 \times (V_{VREG} + V_F)}{S_E} \quad (2)$$

If equation 2 yields an inductor value that is not a standard value, then the next closest available value should be used. The final inductor value should allow for 10%-20% of initial tolerance and 20%-30% for inductor saturation.

Due to topology and frequency switching of the ARG82800 pre-regulator, the inductor ripple current varies with input voltage per Figure 8 below:



**Figure 8: Typical Peak Inductor Current versus Input Voltage for 0.8 A Output Current and 10 μH Inductor**

The inductor should not saturate given the peak operating current during overload. Equation 3 calculates this current. In equation 3,  $V_{VIN(MAX)}$  is the maximum continuous input voltage, such as 16 V, and  $V_F$  is the asynchronous diode's forward voltage.

$$I_{PEAK} = I_{LIM(ton,min)max} - \frac{S_E \times (V_{VREG} + V_F)}{0.9 \times f_{SW} \times (V_{VIN(MAX)} + V_F)} \quad (3)$$

After an inductor is chosen, it should be tested during output overload and short-circuit conditions. The inductor current should be monitored using a current probe. A good design should ensure the inductor or the regulator are not damaged when the output is shorted to ground at maximum input voltage and the highest expected ambient temperature.

Inductor ripple current can be calculated using equation 4 for buck mode, and equation 5 for buck-boost mode.

$$\Delta I_L = \frac{(V_{VIN} - V_{VREG}) \times V_{VREG}}{f_{SW} \times L \times V_{VIN}} \quad (4)$$

$$\Delta I_{L(B/B)} = \frac{V_{VIN} \times D_{BOOST}}{f_{SW} \times L} \quad (5)$$

## Pre-Regulator Output Capacitors

The output capacitors filter the output voltage to provide an acceptable level of ripple voltage. They also store energy to help maintain voltage regulation during a load transient. The voltage rating of the output capacitors must support the output voltage with sufficient design margin.

The output voltage ripple ( $\Delta V_{VREG}$ ) is a function of the output capacitors parameters:  $C_O$ ,  $ESR_{CO}$ ,  $ESL_{CO}$ .

$$\Delta V_{VREG} = \Delta I_L \times ESR_{CO} + \frac{V_{VIN} - V_{VREG}}{L} \times ESL_{CO} + \frac{\Delta I_L}{8 \times f_{SW} \times C_O} \quad (6)$$

The type of output capacitors will determine which terms of equation 6 are dominant. For ceramic output capacitors, the  $ESR_{CO}$  and  $ESL_{CO}$  are virtually zero, so the output voltage ripple will be dominated by the third term of equation 6.

$$\Delta V_{VREG} = \frac{\Delta I_L}{8 \times f_{SW} \times C_O} \quad (7)$$

To reduce the voltage ripple of a design using ceramic output capacitors, simply increase the total capacitance, reduce the inductor current ripple (i.e. increase the inductor value), or increase the switching frequency.

The transient response of the regulator depends on the number and type of output capacitors. In general, minimizing the ESR of the output capacitance will result in a better transient response. The ESR can be minimized by simply adding more capacitors in parallel or by using higher quality capacitors. At the instant of a fast load transient (di/dt), the output voltage will change by the amount:

$$\Delta V_{VREG} = \Delta I_{LOAD} \times ESR_{CO} + \frac{di}{dt} \times ESL_{CO} \quad (8)$$

After the load transient occurs, the output voltage will deviate from its nominal value for a short time. This time will depend on the system bandwidth, the output inductor value, and output capacitance. Eventually, the error amplifier will bring the output voltage back to its nominal value.

The speed at which the error amplifier will bring the output voltage back to its setpoint will depend mainly on the closed-loop bandwidth of the system. A higher bandwidth usually results in a shorter time to return to the nominal voltage. However, a higher bandwidth system may be more difficult to obtain acceptable gain and phase margins. Selection of the compensation components ( $R_Z$ ,  $C_Z$ ,  $C_P$ ) are discussed in more detail in the Compensation Components section of this datasheet.

## Ceramic Input Capacitors

The ceramic input capacitor(s) must limit the voltage ripple at the VIN pin to a relatively low voltage during maximum load. Equation 8 can be used to calculate the minimum input capacitance,

$$C_{IN} \geq \frac{I_{VREG(MAX)} \times 0.25}{0.90 \times f_{SW} \times 50 \text{ mV}} \quad (9)$$

where  $I_{VREG(MAX)}$  is the maximum current from the pre-regulator,

$$I_{VREG(MAX)} = I_{LINEAR} + I_{AUX} + 20 \text{ mA} \quad (10)$$

where  $I_{LINEAR}$  is the sum of all the internal linear regulators output currents,  $I_{AUX}$  is any extra current drawn from the VREG output to power other devices external to the ARG82800.

A good design should consider the DC bias effect on a ceramic capacitor—as the applied voltage approaches the rated value, the capacitance value decreases. The X5R and X7R type capacitors

should be the primary choices due to their stability versus both DC bias and temperature. For all ceramic capacitors, the DC bias effect is even more pronounced on smaller case sizes, so a good design will use the largest affordable case size.

Also for improved noise performance, it is recommended to add smaller sized capacitors close to the input pin and the D1 anode. Use a 0.1 μF 0603 capacitor or less.

## Buck-Boost Asynchronous Diode (D1)

The highest peak current in the asynchronous diode (D1) occurs during overload and is limited by the ARG82800. Equation 3 can be used to calculate this current.

The highest average current in the asynchronous diode occurs when  $V_{VIN}$  is at its maximum,  $D_{BOOST} = 0\%$ , and  $D_{BUCK} = \text{minimum}$  (10%),

$$I_{AVG} = 0.9 \times I_{VREG(MAX)} \quad (11)$$

where  $I_{VREG(MAX)}$  is calculated using equation 10.

## Boost MOSFET (Q1)

The RMS current in the boost MOSFET (Q1) occurs when  $V_{VIN}$  is at its minimum and both the buck and boost operate at their maximum duty cycles (approximately 64% and 58%, respectively),

$$I_{Q1(RMS)} = \sqrt{D_{BOOST} \times \left[ \left( I_{PEAK} - \frac{\Delta I_{L(B/B)}}{2} \right)^2 + \frac{\Delta I_{L(B/B)}^2}{12} \right]} \quad (12)$$

where  $\Delta I_{L(B/B)}$  and  $I_{PEAK}$  are derived using equations 3 and 5, respectively.

## Boost Diode (D2)

In buck mode, this diode will simply conduct the output current. However, in buck-boost mode, the peak currents in this diode may increase a lot. The ARG82800 limits the peak current to the value calculated using equation 3. The average current is simply the output current.

## Pre-Regulator Compensation Components ( $R_Z$ , $C_Z$ , $C_P$ )

Although the ARG82800 can operate in buck-boost mode at low input voltages, it still can be considered a buck converter when looking at the control loop. The following equations can be used to calculate the compensation components.

First, select the target crossover frequency for the final system.

While switching at over 2 MHz, the crossover is governed by the required phase margin. Since a type II compensation scheme is used, the system is limited to the amount of phase that can be added. Hence, a crossover frequency,  $f_C$ , in the region of 55 kHz is selected. The total system phase will drop off at higher crossover frequencies. The  $R_Z$  selection is based on the gain required at the crossover frequency and can be calculated by the following simplified equation:

$$R_Z = \frac{13.36 \times \pi \times f_C \times C_O}{g_{mPOWER} \times g_{mEA}} \quad (13)$$

where  $f_C$  is in kHz,  $C_O$  (actual capacitance at 5.35 V DC bias) is in μF, and  $R_Z$  will be in kΩ. The  $g_{mPOWER}$  (in A/V) and  $g_{mEA}$  (in μA/V) can be found in the Electrical Characteristic table.

The series capacitor,  $C_Z$ , along with the resistor,  $R_Z$ , set the location of the compensation zero. This zero should be placed no lower than ¼ the crossover frequency and should be kept to a minimum value. Equation 14 can be used to estimate this capacitor value.

$$C_Z > \frac{4}{2\pi \times R_Z \times f_C} \quad (14)$$

where  $f_C$  is in kHz,  $R_Z$  is in kΩ, and  $C_Z$  will be in μF.

Determine if the second compensation capacitor ( $C_P$ ) is required. It is required if the ESR zero of the output capacitor is located at less than half of the switching frequency or the following relationship is valid:

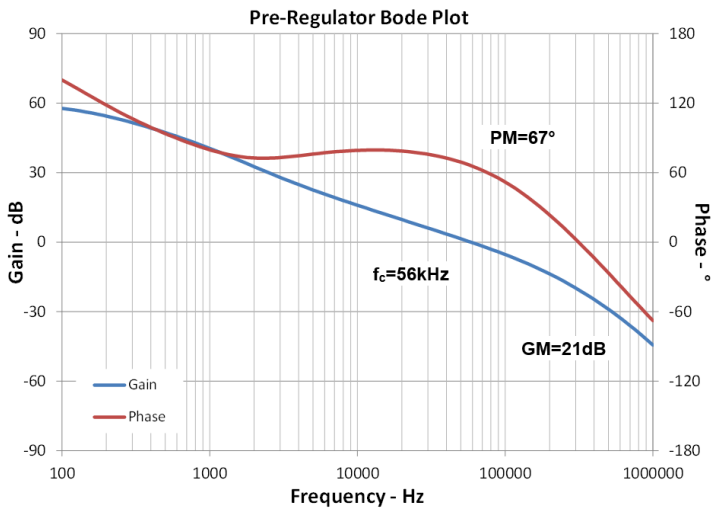
$$\frac{1}{2\pi \times C_O \times ESR_{CO}} < \frac{f_{SW}}{2} \quad (15)$$

If this is the case, then add the second compensation capacitor ( $C_P$ ) to set the pole at the location of the ESR zero. Determine the  $C_P$  value by the equation:

$$C_P = \frac{C_{OUT} \times ESR_{CO}}{R_Z} \quad (16)$$

where  $C_O$  is in μF,  $ESR_{CO}$  is in mΩ,  $R_Z$  is in kΩ, and  $C_Z$  will be in pF.

An Excel-based design tool is available from Allegro that accepts customer specifications and recommended values for both power and compensation components. The pre-regulator bode plot in Figure 9 was generated with this tool. The bandwidth of this system ( $f_C$ ) is 56 kHz, the phase margin (PM) is 67 degrees, and the gain margin (GM) is 21 dB.



**Figure 9: Bode Plot for Pre-Regulator**  
 $R_Z = 18.2 \text{ k}\Omega$ ,  $C_Z = 3.3 \text{ nF}$ ,  $C_P = 47 \text{ pF}$   
 $L_O = 4.7 \text{ }\mu\text{H}$ ,  $C_O = 3 \times 10 \text{ }\mu\text{F}$  (16V/X7R/1206) MLCC

## Linear Regulators

The four linear regulators only require a single ceramic capacitor located near ARG82800 terminals to ensure stable operation. The range of acceptable values is shown in the Electrical Characteristics table. A 2.2  $\mu\text{F}$  capacitor per regulator is recommended.

Also, since the V5P1 and V5P2 are used to power remote circuitry, their load may include external wiring. The inductance of this wiring may cause LC-type ringing and negative spikes on the V5P1 (V5P2) pin if a “fast” short-to-ground occurs. It is recommended a small Schottky diode be placed close to the V5P1 (V5P2) pin to clamp this negative spike. The MSS1P5 (or equivalent) is a good choice.

## Internal Bias (VCC)

The internal bias voltage should be decoupled at the VCC pin using a 1  $\mu\text{F}$  ceramic capacitor. It is not recommended to use this pin as a source.

## Signal Pins (NPOR, FFn, POE)

The ARG82800 has many signal level pins. The NPOR, FFn, and ENBAT are open-drain outputs and require external pull-up resistors. Allegro recommends sizing the external pull-up resistors so each pin will sink less than 2 mA when it is a logic low. The POE signal is push-pull output and does not require external pull-up resistor.

## PCB LAYOUT RECOMMENDATIONS

The input ceramic capacitors must be located as close as possible to the VIN pins. In general, the smaller capacitors (0402, 0603) must be placed very close to the VIN pin. The larger capacitors should be placed within 0.5 inches of the VIN pin. There must not be any vias between the input capacitors and the VIN pins.

The pre-regulator asynchronous diode (D1), input ceramic capacitors, and RC snubber must be routed on one layer and “star” grounded at a single location with multiple vias.

The pre-regulator output inductor (L1) should be located close to the LX pins. The LX trace widths (to L1, D1) should be relatively wide and preferably on the same layer as the IC.

The pre-regulators output ceramic capacitors should be located near the VREG pin. There must be 1 or 2 smaller ceramic capacitors as close as possible to the VREG pin.

The four charge pump capacitors must be placed as close as pos-

sible to VCP1, CP1C1/CP1C2 and VCP2, CP2C1/ CP2C2.

The ceramic capacitors for the LDOs (VUC, V5C, V5P1, and V5P2) must be placed near their output pins. The V5P1 and V5P2 outputs must have a 1 A/40 V Schottky diode located very close to their pins to limit negative voltages.

The VCC bypass capacitor must be placed very close to the VCC pin.

The COMP network of pre-regulators ( $R_Z$ ,  $C_Z$ , and  $C_P$ ) must be located very close to the COMP pin.

The thermal pad under the ARG82800 must connect to the ground plane(s) with multiple vias.

The boost MOSFET (Q1) and the boost diode (D2) must be placed very close to each other. Q1 should have thermal vias to a polygon on the bottom layer. Also, there should be “local” bypass capacitors from D2 cathode to Q1 source.



## PACKAGE OUTLINE DRAWING

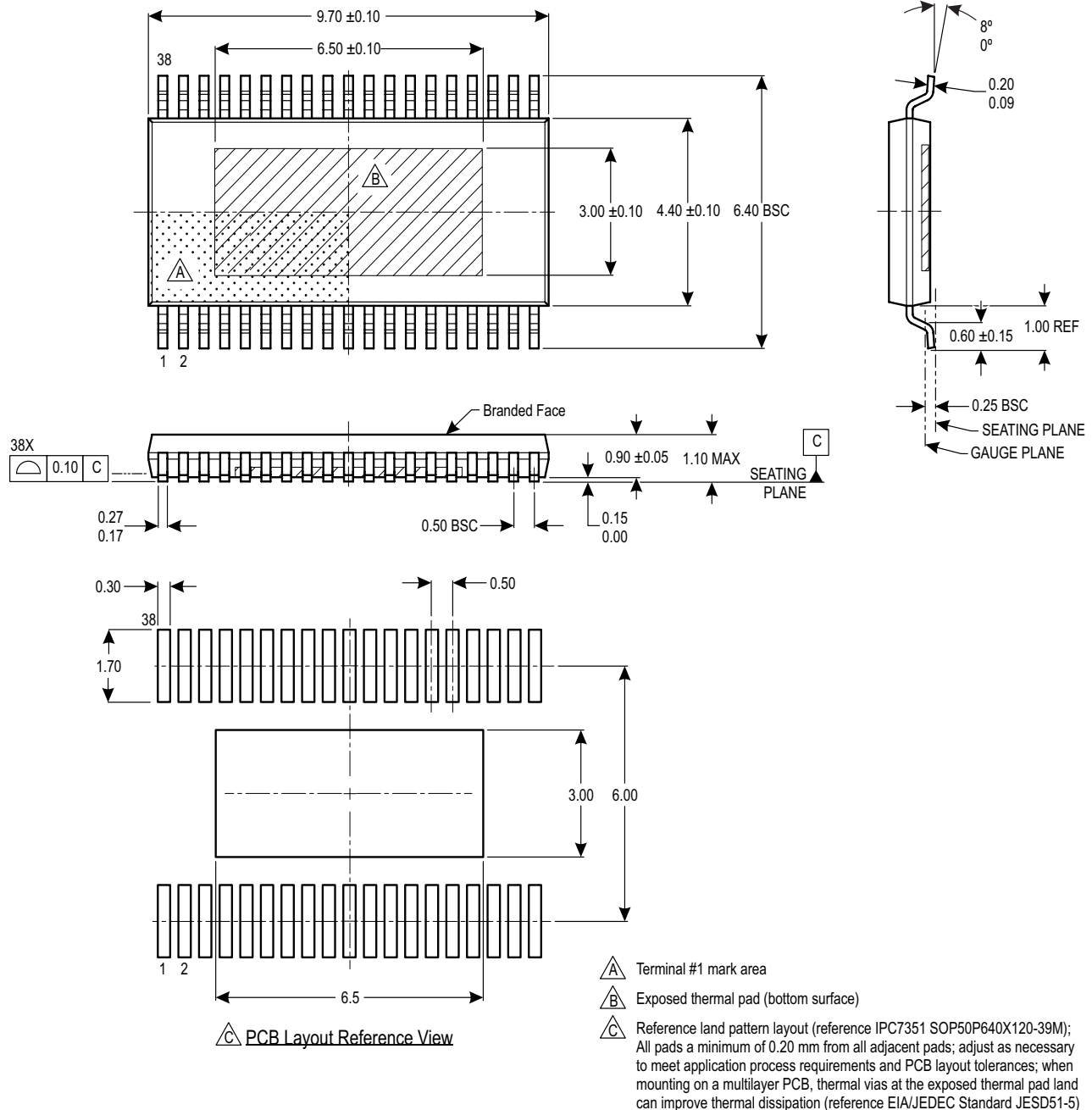
### For Reference Only – Not for Tooling Use

(Reference JEDEC MO-153 BDT-1)

Dimensions in millimeters

NOT TO SCALE

Dimensions exclusive of mold flash, gate burrs, and dambar protrusions  
Exact case and lead configuration at supplier discretion within limits shown



**Figure 10: Package LV, 38-Pin eTSSOP**

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# ARG82800

*Fully Integrated PMIC for Safety-Related Systems  
with Buck or Buck-Boost Pre-Regulator,  
4× Linear Regulators, 4× Gate Drivers, and SPI*

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## Revision History

Number	Date	Description
–	October 17, 2017	Initial release
1	November 17, 2017	Minor editorial changes
2	April 23, 2018	Corrected selection guide
3	May 2, 2018	Corrected Status Registers paragraph (page 26) and POE_OK fault register (page 28)

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